

# New Product Release

**Orderer:** Chris Spoon

**Manufacturer:** INSIDE Technology

**Article Name:** 886LCD/ATX  
886LCD/ATXU

**Article Number:** 710010  
710020

**Lot Number:** n. a.

**Sample Serial Number:** 0016A6, 001773  
2114

**PCB Rev:** 1.0

**BIOS Rev:** 6.00PG

Kontron Embedded Modules internal testprocedure file:  
F:\data\mqalpublic\8ATX\8ATXHP10.doc

Responsible Test Engineer

Date: 10.02.2003

Dallmeier Christian  
Service Center Approval

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## 2 General Informations

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## 3 Devices under Test

Box	form factor	CPU	Memory Module
#1	Full ATX	INTEL P4 2,4 GHz	TwinMOS 256MB DDR
#2	Ful ATX	INTEL P4 2,4 GHz	TwinMOS 256MB DDR
#3	Micro ATX	INTEL P4 2,4 GHz	APACER 512MB DDR

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## 4 Temperature Margin Test

### 4.1 Used Hard- and Software

Hardware	Register
DUT#1	Box #3
DUT#2	Box #1
HDD IDE	EA0251
Keyboard	EA0111
Monitor	EA0249
Climatic Chamber	EA0022
Measuring Device	EA0157
Power Supply ATX	EA0235
microServer	
Active Loudspeaker	EA0175

Software
MS DOS 6.22
Windows 98
Amidiag 5.42

### 4.2 General Conditions

Time cycle from Power On to Power Off      min. 3 minutes  
 Time cycle from Power Off to Power On      min 1 minute

<b>Test Preparation</b>	<ul style="list-style-type: none"> <li>Connect LAN Interfaces of DUT to microSERVER</li> <li>COM1-, COM2-, LPT1-Port Test with external <u>loopback</u> connectors.</li> <li>Configure Batch Programs:  <b>Win98.</b> Device under Test has to execute various tests of graphics, network, sound in Win98  <b>Amidiag.</b> Device under Test has to execute various tests of lpt, com, floppy, keyboard, mouse and usb controllers.</li> </ul>
<b>Test Flow</b>	Between Power On and Power Off the controllers for graphics, network, sound, lpt, com, floppy, keyboard, mouse and usb are tested with appropriate test routines.

### 4.3 Temperature Profile

Step	Temp. [°C]	Time [min]	Remarks
1	55	15	Temp const 15 Min, boot
2	55		Run 25 Cycles WIN98
3	55		Run 25 Cycles AMIDIAG
4	40	30	Temp. Change 30 min.
5	40	15	Temp const 15 Min, boot
6	40		Run 25 Cycles WIN98
7	40		Run 25 Cycles AMIDIAG
8	20	30	Temp. Change
9	20	15	Temp const 15 Min, boot
10	20		Run 25 Cycles WIN98
11	20		Run 25 Cycles AMIDIAG
12	0	30	Temp. Change
13	0	15	Temp const 15 Min, boot
14	0		Run 25 Cycles WIN98
15	0		Run 25 Cycles AMIDIAG
16	-10	30	Temp. Change
17	-10	15	Temp const 15 Min, boot
18	-10		Run 25 Cycles WIN98

19	-10		Run 25 Cycles AMIDIAG
20	-20	30	Temp. Change
21	-20	15	Temp const 15 Min, boot
22	-20		Run 25 Cycles WIN98
23	-20		Run 25 Cycles AMIDIAG

**Result:**

X	<b>Test passed successfully</b> Remark: Board of BOX3 shows boot problems when temperatures reach 0°C and below. See summary for further details.	
	Test skipped because	
	Test failed because	

## 4.4 Supply Voltage Ripples

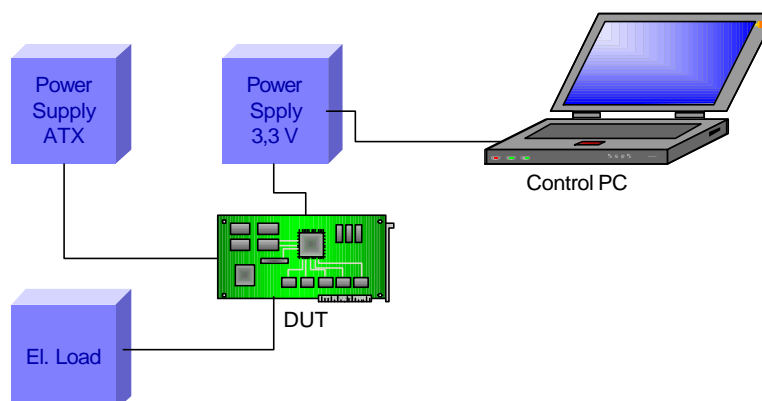
### 4.4.1 DC-DC Converter Overload

- Maximum Power Supply Current (CPU-Core): **65,4 A @ 3,06 Ghz**
- from datasheet: **Intel ® Pentium ® 4 Processor with 512-KB L2 Cache on 0.13 Micron Process at 2 GHz – 3.06 GHz, with Support for Hyper-Threading Technology at 3.06 GHz Document Number: 298643-007**
- Minimum Power Reserve: **20% = 13,08 A @ 3,06 Ghz**

During the Tests Power On (Slow + Fast Ramp) and Power Supply Ripples a Electronic Load drawing the Minimum Power Reserve Current is connected between VCORE and GND. The Electronic Load is connected at Pin1 and 2 of capacitors **EC14 and EC21**

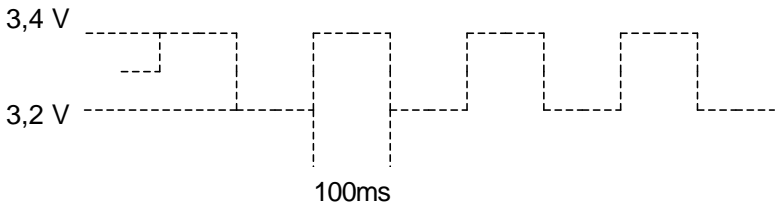
### 4.4.2 Test preparation

#### 4.4.2.1 Ripples on 3,3 V

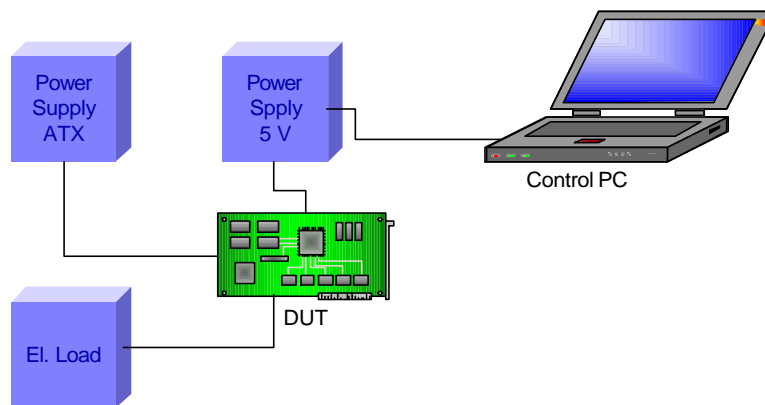


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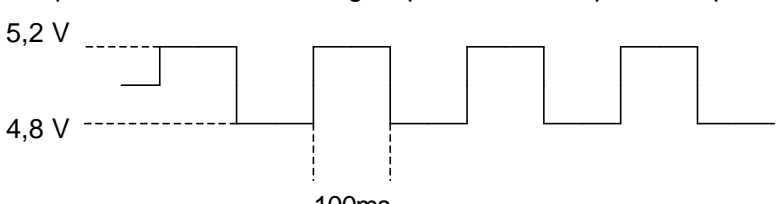
## 4.4.2.2 Test Flow

<b>Preparation</b>	Build up assembly to supply the DUT via the programable HP Power Supply E3632A with Electronic Load attached. ATX Power supplies 5V, 12V and Power Management Signals, HP Power supplies 3,3V
<b>Flow</b>	<p>▶ Running rippfix.exe on the control pc will create the following output on the + output of the power supply:</p>  <p>▶ Boot Win98 100 times.</p>
<b>Result</b>	<p><b>X</b> <b>Test passed successfully</b></p> <p><b>Test failed because</b></p> <p><b>Test skipped because</b></p>

## 4.4.2.3 Ripples on 5 V

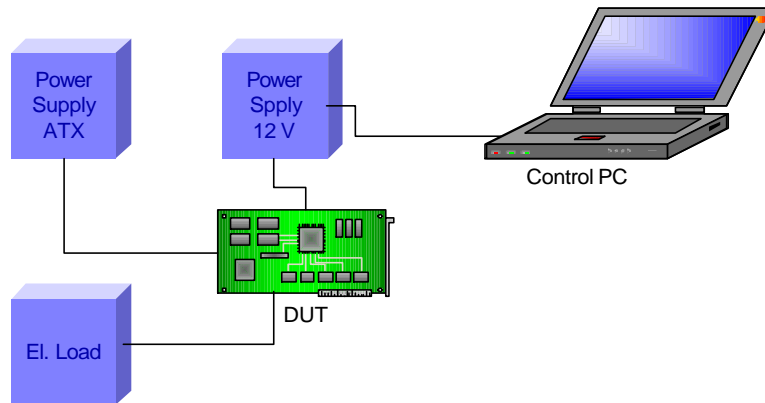


## 4.4.2.4 Test Flow

<b>Preparation</b>	Build up assembly to supply the DUT via the programable HP Power Supply E3632A with Electronic Load attached. ATX Power supplies 3,3V, 12V and Power Management Signals, HP Power supplies 5V
<b>Flow</b>	<p>▶ Running rippfix.exe on the control pc will create the following output on the + output of the power supply:</p>  <p>▶ Boot Win98 100 times.</p>
<b>Result</b>	<p><b>X</b> <b>Test passed successfully</b></p> <p><b>Test failed because</b></p> <p><b>Test skipped because</b></p>

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4.4.2.5 Ripples on 12 V (CPU Supply Voltage)



4.4.2.6 Test Flow

<b>Preparation</b>	Build up assembly to supply the DUT via the programable HP Power Supply E3632A with Electronic Load attached. ATX Power supplies 3,3V, 5V and Power Managment Signals, HP Power supplies 12V
<b>Flow</b>	<p>▶ Running rippfix.exe on the control pc will create the following output on the + output of the power supply:</p> <p>▶ Boot Win98 100 times.</p>
<b>Result</b>	<p><b>X</b> <b>Test passed successfully</b></p> <p><b>Test failed because</b></p> <p><b>Test skipped because</b></p>

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# 5 Power On Test

## 5.1 Used Hard- and Software

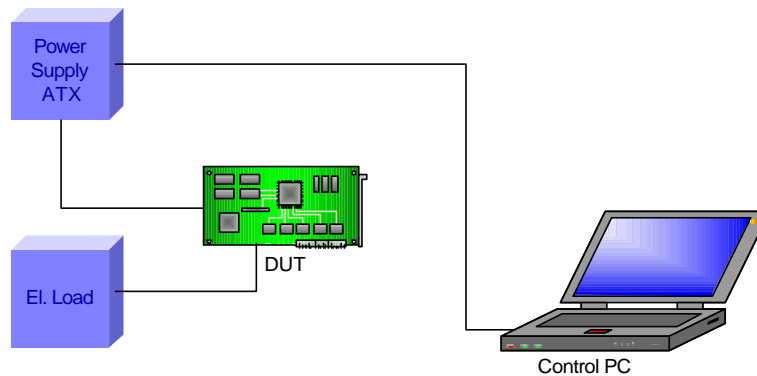
Hardware	Register
DUT	Box3
Monitor	EA0296
Keyboard	EA0254
ChipDisk	EA0120
El. Load	Höcherl & Hackl
Power Supply AT	EA0045
Oscilloscope	LeCroy

Software
MS-DOS 6.22
Kontron HP.EXE
Kontron counter.exe

## 5.2 General Conditions

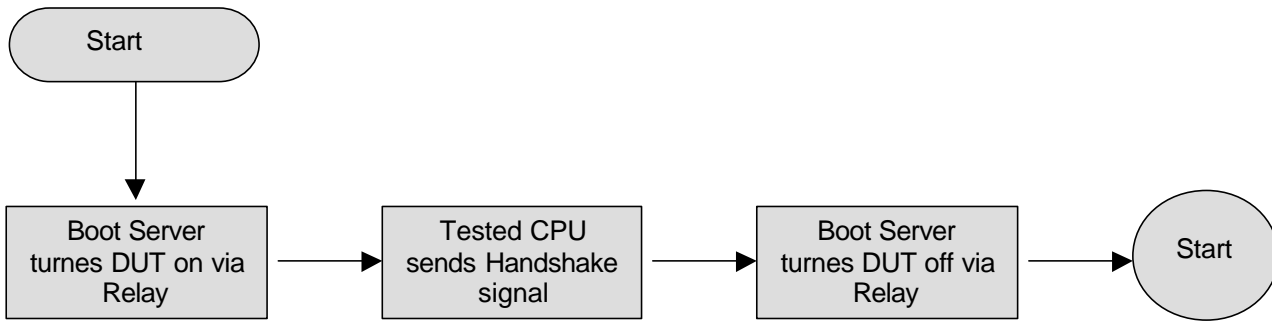
- ▶ 20% DCDC-Converter Overload as described above
- ▶ Ambient Temperature: 25°C
- ▶ CPU: Intel P4 2,4 Ghz/533 MHz
- ▶ Memory: 512 MB DDR
- ▶ Set BIOS Default Settings

### 5.2.1 Test preparation



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### 5.3 Test Flow: 0V to 5 V (Fast Ramp)



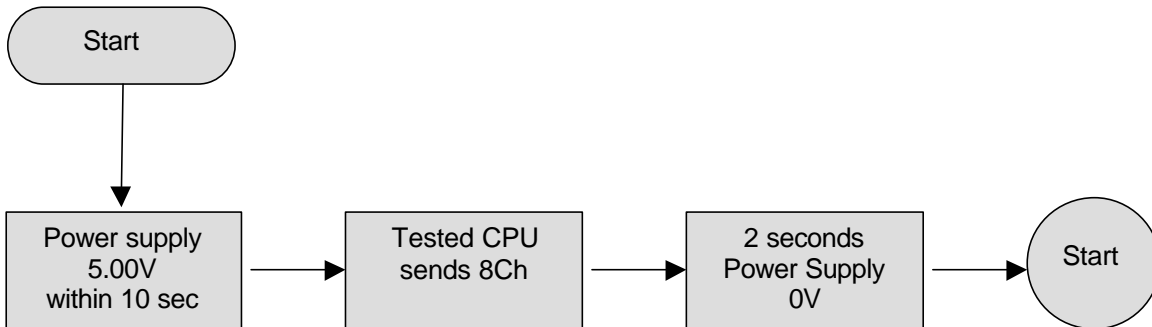
Number of cycles: >500

Result:

X	Test passed successfully	
	Test skipped because	
	Test failed because	

### 5.4 Test Flow: 0V to 5 V (Slow Ramp)

Applying power with  $\Delta U / \Delta t = 0.5 \text{ V/s}$



Number of cycles:

Result:

	Test passed successfully	
X	Test skipped because	Not applicable (ATX Power On Behaviour)
	Test failed because	

### 5.5 DC-DC Converter Quality

Preparation	<ul style="list-style-type: none"> <li>▶ Build up Test assembly shown in 4.2.1</li> <li>▶ Dut has to be started with Power Button to generate a Fast Ramp</li> <li>▶ Build up assembly of display test with simultan output to maximize load</li> <li>▶ Prepare Measurement Points as described below</li> <li>▶ Load Oscilloscope panels to execute dc-dc measurements</li> </ul>				
	Flow	<table border="1"> <tr> <td>VCC<sub>CORE</sub> Fast Ramp</td> <td>▶ Press Power Button to start DUT ▶ Measure V<sub>12V</sub> (DC-DC Converter input) and Vcore</td> </tr> <tr> <td>FFT VCC<sub>CORE</sub></td> <td>▶ Measure FFT of Vcore</td> </tr> </table>	VCC <sub>CORE</sub> Fast Ramp	▶ Press Power Button to start DUT ▶ Measure V <sub>12V</sub> (DC-DC Converter input) and Vcore	FFT VCC <sub>CORE</sub>
VCC <sub>CORE</sub> Fast Ramp	▶ Press Power Button to start DUT ▶ Measure V <sub>12V</sub> (DC-DC Converter input) and Vcore				
FFT VCC <sub>CORE</sub>	▶ Measure FFT of Vcore				
Result	<table border="1"> <tr> <td>VCC<sub>CORE</sub> Fast Ramp</td> <td rowspan="2">See screendumps below</td> </tr> <tr> <td>FFT VCC<sub>CORE</sub></td> </tr> </table>	VCC <sub>CORE</sub> Fast Ramp	See screendumps below	FFT VCC <sub>CORE</sub>	
VCC <sub>CORE</sub> Fast Ramp	See screendumps below				
FFT VCC <sub>CORE</sub>					

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## 5.5.1 Measurement Points

To get most accurate results of the properties on the  $V_{CORE}$  – Plane and  $V_{3V}$ -Plane respectively a capacitor between  $V_{CORE}$  and GND is removed and the probe of the scope is attached to these free pads. The capacitor to remove should be as near as possible at the CPU and at the greatest 3.3V consumer (e.g. graphics controller) respectively. The removed capacitor is soldered on back of any near capacitor between  $V_{CORE}$  and GND.

Measurement point  $V_{CORE}$  : Pin 1 of EC26

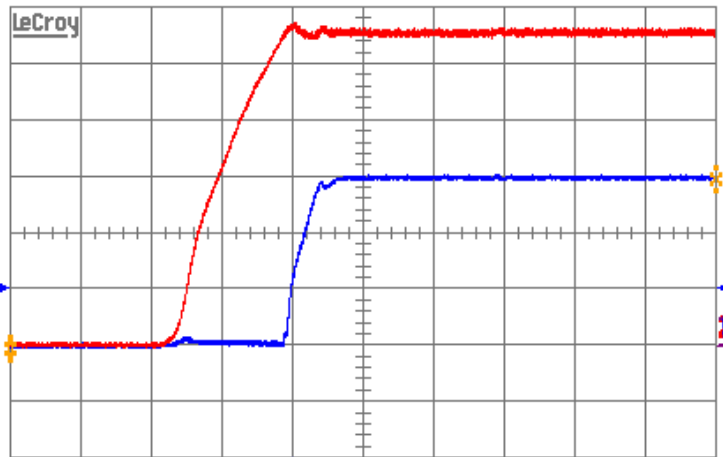
## 5.5.2 $V_{CC_{CORE}}$

### 5.5.2.1 Fast Ramp without el. Load

23-Jan-03  
12:44:36

2  
10 ms  
2.00 V

1  
10 ms  
0.50 V



	1 sweeps:	average	low	high	sigma
period(1)		---	---	---	---
width(1)		---	---	---	---
rise(1)		4.0197 ms	4.0197	4.0197	---
Fall(1)		---	---	---	---
delay(1)		673.5 $\mu$ s	673.5	673.5	---

10 ms

1 50 mV DC  $\times 10$   
2 .2 V DC  $\times 10$   
3 1 V AC  
4 50 mV AC



1 HFREJ 0.53 V

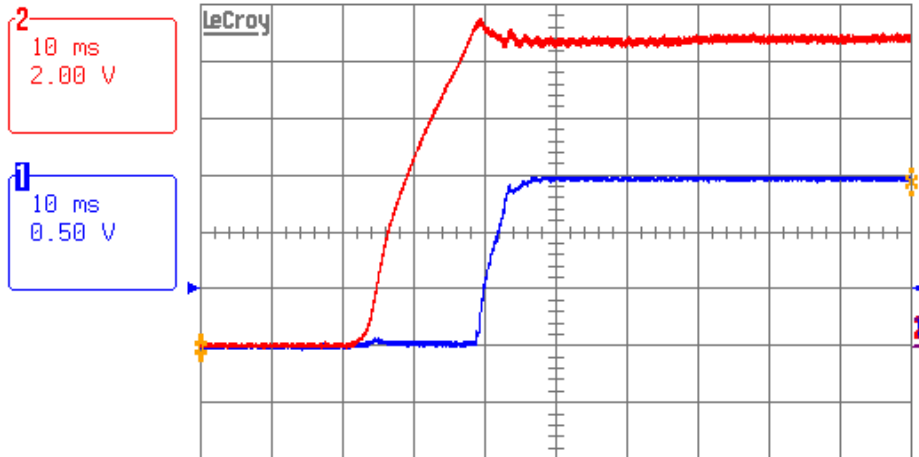
1 MS/s

STOPPED

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5.5.2.2 Fast Ramp with el. Load attached

23-Jan-03  
12:46:54



	1 sweeps:	average	low	high	sigma
period(1)		---	---	---	---
width(1)		---	---	---	---
rise(1)		3.8597 ms	3.8597	3.8597	---
Fall(1)		---	---	---	---
delay(1)		652.2 $\mu$ s	652.2	652.2	---

10 ms

- 1 50 mV DC  $\times 10$
- 2 .2 V DC  $\times 10$
- 3 1 V AC
- 4 50 mV AC



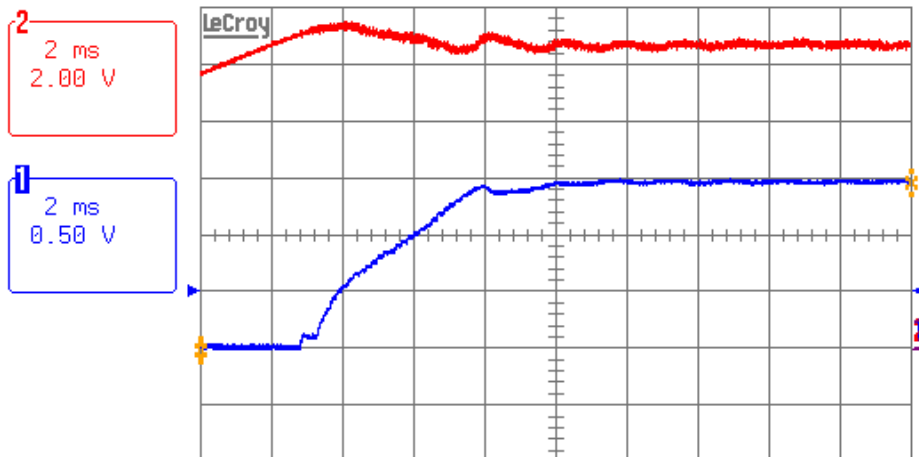
1 HFREJ 0.53 V

1 MS/s

STOPPED

5.5.2.3 Fast Ramp with el. Load attached (Timebase expanded)

23-Jan-03  
12:48:36



	1 sweeps:	average	low	high	sigma
period(1)		---	---	---	---
width(1)		---	---	---	---
rise(1)		3.96609 ms	3.96609	3.96609	---
Fall(1)		---	---	---	---
delay(1)		807.56 $\mu$ s	807.56	807.56	---

2 ms

- 1 50 mV DC  $\times 10$
- 2 .2 V DC  $\times 10$
- 3 1 V AC
- 4 50 mV AC



1 HFREJ 0.53 V

5 MS/s

STOPPED

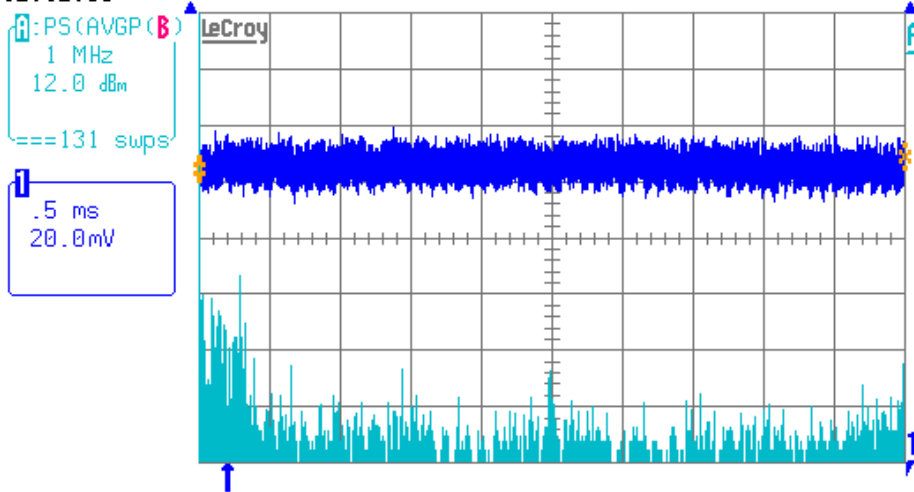
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### 5.5.3 FFT

#### 5.5.3.1 VCC<sub>Core</sub>

23-Jan-03  
12:12:00

Reading Floppy Disk Drive



	130 sweeps:	average	low	high	sigma
pkpk(1)		24.5mV	18.8	37.5	3.8
mean(1)		1.44742 V	1.43212	1.44851	0.00156
sdev(1)		3.04mV	2.37	4.32	0.59
rms(1)		1.44742 V	1.43212	1.44851	0.00156
ampl(1)		24.5mV	18.8	37.5	3.8

.5 ms

- 1 2 mV DC
- 2 trig only
- 3 .1 V AC
- 4 trig only

1 HFREJ 1.5220 V

20 MS/s

STOPPED

## 5.6 DC-DC Converter Loop Compensation

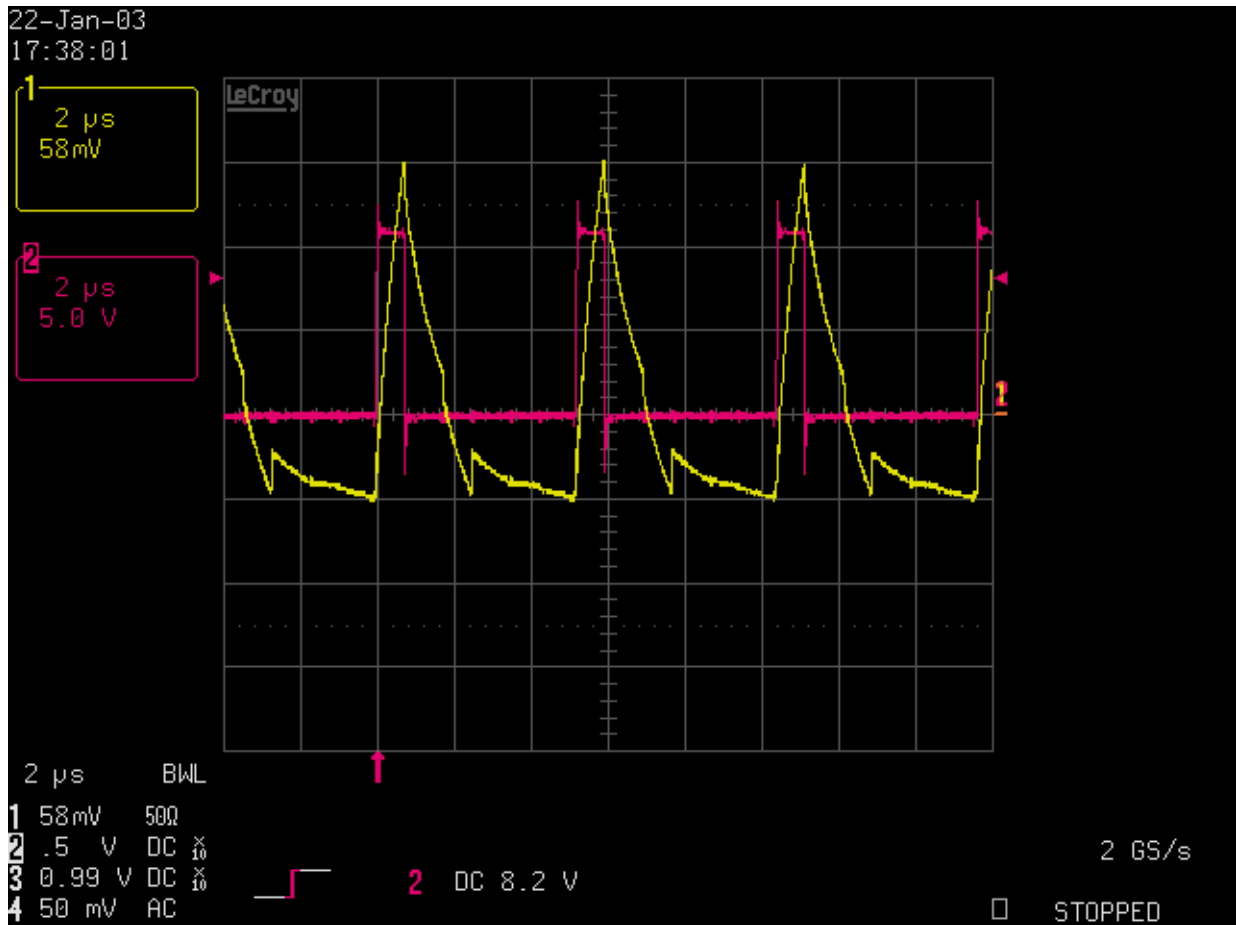
### 5.6.1 3.3V

Preparation	<ul style="list-style-type: none"> <li>▶ Disconnect Electronic Load</li> <li>▶ Build up assembly of display test with simultan output to maximize load</li> <li>▶ Unpick trace section between switching regulator and coil.</li> <li>▶ Insert current measurement coil</li> </ul>
Flow	<ul style="list-style-type: none"> <li>▶ Boot Win 2k and play starwars.mpg</li> <li>▶ Measure Current through coil</li> <li>▶ Measure Voltage of regulator output gates</li> <li>▶ Insert scope screendump into test report</li> </ul>
Result	<b>Test passed successfully</b>
	<b>Test failed because</b>
	<b>X Test skipped because 3.3 V are generated by ATX Power Supply</b>

### 5.6.2 V<sub>CORE</sub>

Preparation	<ul style="list-style-type: none"> <li>▶ Disconnect Electronic Load</li> <li>▶ Unpick trace section between switching regulator and coil.</li> <li>▶ Insert current measurement coil</li> </ul>
Flow	<ul style="list-style-type: none"> <li>▶ Boot Win 2k and run cpustress.exe</li> <li>▶ Measure Current through coil</li> <li>▶ Measure Voltage of regulator output gates</li> <li>▶ Insert scope screendump into test report</li> </ul>
Result	<b>X Test passed successfully</b>
	<b>Test failed because</b>
	<b>Test skipped because</b>

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**Screenshot****5.7 DC-DC Converter Stress Test**

<b>Preparation</b>	▶ Disconnect Electronic Load
<b>Flow</b>	<ul style="list-style-type: none"> <li>▶ Boot Win2k</li> <li>▶ Set board into standby mode</li> <li>▶ Awake board via kbd hit</li> <li>▶ Conduct 500 standby/awake cycles</li> </ul>
<b>Result</b>	<b>Test passed successfully</b>
	<b>Test failed because</b>
	<b>X Test skipped because test software is not compatible.</b>

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## 6 Function Test

### 6.1 Used Hard- and Software

Hardware	Register
DUT	BOX1
HDD IDE	EA0211
FDD	EA0278
Mouse PS/2	EA0202
Monitor	EA0221
Keyboard	EA0222
ChipDisk	EA0120

Software
Microsoft MS-DOS 6.22
Microsoft Windows 98
CHECK IT 4
AMIDIAG 5.42
Additional driver software depending on used controllers

### 6.2 Remark

For further function tests see Doc. **886LCD-ATXU\_Testreport**.

### 6.3 Properties of Used Connectors

- ▶ Loopback COM: 3m ribbon cable with 2200pF between Transmit Data line and GND line
- ▶ Loopback LPT: 5m ribbon cable with loopback

### 6.4 Diagnosis Programs

#### 6.4.1 CMOS Settings

Feature	Setting
Set Optimized Settings.	

#### 6.4.2 Check It 4

<b>Test Flow</b>	Run 3 cycles of <ul style="list-style-type: none"> <li>▶ „Systemplatinen“ Test</li> <li>▶ COM1-, COM2-, LPT1-Port Test with external <u>loopback</u> connectors.</li> </ul>
<b>Result</b>	<b>X</b> <b>Test passed successfully</b>
	<b>Test failed because</b>
	<b>Test skipped because</b>

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### 6.4.3 AMIDIAG

<b>Test Flow</b>	Run 3 cycles of <ul style="list-style-type: none"> <li>▶ All tests in the System tab ( Processor, DMA Controller, Interrupt Controller, Timer, RTC, CMOS Validity, PCI(if applicable), Plug-n-play(if applicable), MMX(if applicable) )</li> <li>▶ PC speaker Test</li> <li>▶ COM1-, COM2-, LPT1-Port Test with external <u>loopback</u> connectors.</li> </ul>
<b>Result</b>	<b>X</b> <b>Test passed successfully</b> Remark: <i>RTC Periodic Interrupt not coming.</i> This is a known behaviour of the Test software with comparatively fast processors and not seen as a problem.
	<b>Test failed because</b>
	<b>Test skipped because</b>

## 6.5 Filetransfer over COM

<b>Test Preparation</b>	Connect DUT and Approval Server via Zero Modem cable
<b>Test Flow</b>	<ul style="list-style-type: none"> <li>▶ Start Windows Hyperterminal on DUT and Approval Server with settings 115,2k;8;1;no parity</li> <li>▶ Transmit Test.txt (1MB) from and to Approval Server and note needed time</li> <li>▶ Repeat Test with COM1-, COM2-Port</li> </ul>

Port	Size of Testfile / Time in sec (from Approval Server)	Size of Testfile / Time in sec (to EVAL-Server)
COM1	1024KB / 91sec	1024KB / 91sec
COM2	1024KB / 91sec	1024KB / 91sec
<b>X</b>	<b>Test passed successfully</b>	
	<b>Test skipped because</b>	

## 6.6 FDD Test

<b>Test Flow</b>	<ul style="list-style-type: none"> <li>▶ Boot MS-DOS 6.22</li> <li>▶ Run CheckIt Floppy Test</li> <li>▶ Format Floppy disk with option /s</li> <li>▶ Boot from Floppy Disk Drive</li> </ul>
<b>Result</b>	<b>X</b> <b>Test passed successfully</b>
	<b>Test failed because</b>
	<b>Test skipped because</b>

## 6.7 Network EEPROM Test

- ▶ Verify that MAC adress is correctly programmed
- ▶ Assure that the MAC adress matches the various company codes as in the following list, where x is a hexadecimal digit:
  - ▶ Kontron Embedded: E04Bxxxxxx
  - ▶ Adastra : 200Cxxxxxx
  - ▶ Inside Technologies: E0F4xxxxxx
  - ▶ Kontron Elektronik: 0060xxxxxx
  - ▶ Pep: 8082xxxxxx

Result:

<b>Read out MAC Adress</b>	<b>00-09-1E-00-16-A6</b>
<b>X</b>	<b>Test passed successfully</b>
	<b>Test skipped because</b>
	<b>Test failed because</b>

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# 7 Bios Features Test

## 7.1 ACPI Power Saving Modes

Test Preparation	Tested by Kontron DK. Testreport: <b>886LCD-ATXu_TestReport</b>	
Test Flow		
Result	X	<b>Test passed successfully</b>
		<b>Test failed because</b>
		<b>Test skipped because</b>

## 7.2 USB Legacy/ Boot Support

Test Flow	▶ Tested by Kontron DK. Testreport: <b>886LCD-ATXu_TestReport</b>	
Result	X	<b>Test passed successfully</b> <b>Remark: No Legacy Boot Support</b>
		<b>Test failed because</b>
		<b>Test skipped because</b>

## 7.3 Wake on LAN

Test Flow	Tested by Kontron DK. Testreport: <b>886LCD-ATXu_TestReport</b>	
Result	X	<b>Test passed successfully</b>
		<b>Test failed because</b>
		<b>Test skipped because</b>

## 7.4 BIOS Power Saving settings

Test Flow	Test proper function of BIOS Power Saving settings and measure current consumption Test video off / hdd off modes Run APM Test of AMldiag	
Available Modes	Standby	<b>789 mA on 12V cord</b> (defined as S1 State in BIOS description)
	Suspend	<b>788 mA on 12V cord</b> (defined as S3 State in BIOS description)
Result	X	<b>Test passed successfully</b>
		<b>Test failed because</b>
		<b>Test skipped because</b>

## 7.5 CPU clock throttling / CPU clock/thermal control

Test Flow	▶ Tested by Kontron DK. Testreport: <b>886LCD-ATXu_TestReport</b>	
Result	X	<b>Test passed successfully</b>
		<b>Test failed because</b>
		<b>Test skipped because</b>

## 7.6 Boot Test

Test Flow	▶ Tested by Kontron DK. Testreport: <b>886LCD-ATXu_TestReport</b>	
Result	X	<b>Test passed successfully</b>
		<b>Test failed because</b>
		<b>Test skipped because</b>

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## 7.7 Flashing BIOS

<b>Test Flow</b>	▶ Tested by Kontron DK. Testreport: <b>886LCD-ATXu_TestReport</b>	
<b>Result</b>	<b>X</b>	<b>Test passed successfully</b>
		<b>Test failed because</b>
		<b>Test skipped because</b>

# 8 Operating Systems Test

## 8.1 Used Hard- and Software

Hardware	Register
DUT	Box #3
HDD IDE	EA0271
CD ROM IDE	EA0164
FDD	EA0257
FDD USB	EA0203
Mouse PS/2	EA0202
Mouse serial	EA0226
Mouse USB	EA0261
Printer	EA0124
Monitor	EA0221
Keyboard	EA0222

Software
Microsoft Windows 98
Microsoft Windows 2000
Additional driver software depending on used controllers

## 8.2 Windows 98

Install Medium:	<b>IDE HDD 3½" on Primary Master</b>			
	Preparation:	fdisk format	File System: Size:	FAT <b>4000</b> MB
Additional BIOS Settings:	Menu	Setting		
	<b>Load Optimized Defaults</b>			
	<b>Advanced BIOS Features</b>	<b>First Boot Device</b>	<b>Floppy</b>	
		<b>Second Boot Device</b>	<b>CDROM</b>	
		<b>Third Boot Device</b>	<b>HDD-0</b>	
Install Procedure:	<b>Boot from Win98 CD-ROM on Primary Slave</b>			
Installation length approx.	<b>12</b>	min		

Driver	Manufacturer	Driver Version	Driver Date
Graphics	INTEL	4.13.01.3317	n. a.
ChipSet	INTEL	4.10.1012	n. a.
USB	INTEL		12-11-2001
Sound	Avance Logic, Inc.	5.10.3960	8-15-2002
LAN	Realtek	4.10.2222	8-23-2001

## Verification of Functionality

X	Mouse PS/2		X	Mouse Serial COM1-2		X	Printer Testpage
X	Sound	Verifying sound functionality by connecting Active Loudspeakers and playing jump.wav with windows media player.					
X	Network	Verifying ethernet functionality by connecting to Kontron Embedded Network					
X	USB (6 channels)	<ul style="list-style-type: none"> <li>▶ Checking USB functionality by connecting USB-Mouse and running usbview.exe;</li> <li>▶ Connect USB FDD and copy files from USB FDD to HDD and FDD</li> </ul>					
		Used Batch File:	<pre>md f:\test copy c:\windows\media\*. * f:\test fc f:\test\*. * c:\windows\media\*. * deltree /y f:\test</pre>				

## Result:

X	Test passed successfully	
	Test skipped because	
	Test failed because	

## 8.2.1 Power Management Test

Test Flow	<ul style="list-style-type: none"> <li>▶ Press &lt;Ctrl&gt; + &lt;Alt&gt; + &lt;Del&gt; two times</li> <li>▶ &lt;Start&gt; → Shutdown</li> <li>▶ &lt;Start&gt; → Shutdown to MS DOS mode</li> <li>▶ &lt;Start&gt; → Restart</li> <li>▶ Set Power Management Modes: <ul style="list-style-type: none"> <li>▶ Switch off monitor after 2 min</li> <li>▶ Switch off harddisk after 5 min</li> </ul> </li> </ul>
-----------	--

## Result:

X	Test passed successfully	
	Test skipped because	
	Test failed because	

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## 8.3 Windows 2000

Install Medium:	<b>IDE HDD 3½" on Secondary Master</b>			
	Preparation:	fdisk format	File System: Size:	FAT 4000
Additional BIOS Settings:	Menu		Setting	
	Load Optimized Defaults			
	Advanced BIOS Features	First Boot Device Second Boot Device Third Boot Device	Floppy CDROM HDD-0	
Install Procedure:	<ul style="list-style-type: none"> <li>• <b>Boot from Win2000 CD-ROM on Primary Master</b></li> <li>• <b>Change Filesystem into NTFS during Installation</b></li> </ul>			
Installation length approx.	33	min		

Driver	Manufacturer	Driver Version	Driver Date
Graphics	INTEL	6.13.01.3317	25.10.2002
ChipSet	INTEL	4.10.1012	n. a.
USB	INTEL	5.1.3538.1	
Sound	Avance Logic, Inc.	5.10.0.3960	n. a.
LAN	Realtek	5.366.818.1999	19.10.1999

### Verification of Functionality

X	Mouse PS/2	X	Mouse Serial COM1-2	X	Printer Testpage
X	Sound	Verifying sound functionality by connecting Active Loudspeakers and playing jump.wav with windows media player.			
X	Network	Verifying ethernet functionality by connecting to Kontron Embedded Network			
X	USB	<ul style="list-style-type: none"> <li>▶ Checking USB functionality by connecting USB-Mouse and running usbview.exe;</li> <li>▶ Connect USB FDD and copy files from USB FDD to HDD and FDD</li> </ul>			
		Used Batch File:	<pre>md b:\test copy c:\winnt\media\B*. * b:\test fc c:\winnt\media\B*. * b:\test\*. *</pre>		

### Result:

X	Test passed successfully
	Test skipped because
	Test failed because

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# 9 Hardware Compatibility Test

## 9.1 Used Hard- and Software

Hardware	Register
DUT	BOX1
HDD IDE	EA0251
Monitor	EA0221
Keyboard	EA0222

Software
Microsoft Windows 98
Additional driver software depending on used controllers

## 9.2 PCI Voltage Level

<b>Test Flow</b>	<ul style="list-style-type: none"> <li>▶ Measure <math>V_{3V}</math> on PCI BUS with oscilloscope</li> <li>▶ 3V level signals have to exceed 3,25V</li> </ul>
<b>Result</b>	<b>X Test passed successfully</b>
	<b>Test failed because</b>
	<b>Test skipped because</b>

## 9.3 PCI Slot

<b>Test Flow</b>	Installation of several PCI cards (SCSI-, Modem-, LAN-, Sound) Tested by Kontron DK. Testreport: <b>886LCD-ATXu_TestReport</b>
<b>Result</b>	<b>X Test passed successfully</b>
	<b>Test failed because</b>
	<b>Test skipped because</b>

## 9.4 Mouse

Additional Used Hardware		
Interface	Device	Register
PS/2	Microsoft	EA0095
Serial		EA0226
USB	Qtronix	EA0215

Additional CMOS Settings	
Menu	Setting
Load Optimized Settings	

<b>Test Flow</b>	Ensure proper mouse function.	
<b>Result</b>	PS/2	<b>X Test passed successfully</b>
		<b>Test failed because</b>
		<b>Test skipped because</b>
	Serial	<b>X Test passed successfully</b>
		<b>Test failed because</b>
		<b>Test skipped because</b>
	USB Connect-disconnect-connect in Win98	<b>X Test passed successfully</b>
		<b>Test failed because</b>
		<b>Test skipped because</b>

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## 9.5 Keyboard

Additional Used Hardware		
Interface	Device	Register
DIN	Cherry	EA0063
USB	Cherry	EA0254

Additional CMOS Settings	
Menu	Setting
Load Optimized Settings	
Integrated Peripherals	USB Keyboard Support Enabled

Test Flow		Ensure proper keyboard function.	
Result	PS/2	X	Test passed successfully
			Test failed because
			Test skipped because
	DIN	X	Test passed successfully
			Test failed because
			Test skipped because
	USB Connect-disconnect-connect in MS-DOS	X	Test passed successfully
			Test failed because
			Test skipped because

## 9.6 Zip Drives

Test Flow		▶ Tested by Kontron DK. Testreport: 886LCD-ATXu_TestReport	
Result	X	Test passed successfully	
		Test failed because	
		Test skipped because	

## 9.7 USB

Additional Used Hardware	
Device	Register
Electronic Load	EL7000
Kontron USB Docking Station USB1	EA0260

### 9.7.1 USB Current Load

Test Preparation		Connect Electronic Load to Powerline of USB connector(s)	
Test Flow		Increase current load, until Fuse triggers Fuse trigger threshold must be in the range between 550mA and 700mA Notify Voltage Level on USB Power Line when drawing 550mA Voltage Level @550mA must be exceeding 4,75V	
Voltage Level @	1100mA	USB Stack1 (includes USB3, USB4)	4722 mV Remark: 4753 mV @ 1000 mA
	1100mA	USB Stack2 (includes USB1, USB2)	<b>4810 mV</b>
	1100mA	USB Stack3 (additional USB)	<b>4791 mV</b>
Fuse Trigger Threshold		<b>2100mA @ all USB Stacks</b>	
Result	X	Test passed successfully	
		Test failed because	
		Test skipped because	

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## 9.7.2 USB Docking Station USB1

Test Preparation	<ul style="list-style-type: none"> <li>▶ Connect USB Docking Station USB1</li> <li>▶ Attach IDE HDD to USB1</li> </ul>
Test Flow	<ul style="list-style-type: none"> <li>▶ Boot Win2k</li> <li>▶ Load corresponding drivers</li> <li>▶ Copy 10MB Testfile from USB HDD to IDE HDD and note passing time</li> <li>▶ Performance must exceed 1Mbyte/s</li> </ul>
Result	X <b>Test passed successfully</b>
	<b>Test failed because</b>
	<b>Test skipped because</b>

## 9.8 Hard Disk Drives

Test Flow	▶ Tested by Kontron DK. Testreport: <b>886LCD-ATXu_TestReport</b>
Result	X <b>Test passed successfully</b>
	<b>Test failed because</b>
	<b>Test skipped because</b>

## 9.9 CPUs

Test Flow	▶ Tested by Kontron DK. Testreport: <b>886LCD-ATXu_TestReport</b>
Result	X <b>Test passed successfully</b>
	<b>Test failed because</b>
	<b>Test skipped because</b>

## 9.10 DRAM Modules

Test Flow	▶ Tested by Kontron DK. Testreport: <b>886LCD-ATXu_TestReport</b>
Result	X <b>Test passed successfully</b>
	<b>Test failed because</b>
	<b>Test skipped because</b>

## 9.11 Power Supplies

Test Flow	▶ Tested by Kontron DK. Testreport: <b>886LCD-ATXu_TestReport</b>
Result	X <b>Test passed successfully</b>
	<b>Test failed because</b>
	<b>Test skipped because</b>

## 9.12 AGP Graphics Adapter

Test Flow	▶ Tested by Kontron DK. Testreport: <b>886LCD-ATXu_TestReport</b>
Result	X <b>Test passed successfully</b>
	<b>Test failed because</b>
	<b>Test skipped because</b>

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# 10 Performance Test

## 10.1 Used Hard- and Software

Hardware	Register
DUT	Box 1
DIE HDD	EA0271
DIE CD ROM	EA0164
IDE HDD Seagate 10GB ST310211A	EA0146
Keyboard	EA0222
Monitor	EA0221
Mouse PS/2	EA0138

Software
MS-DOS 6.22
Windows 98
Winbench 99
PC LABS

## 10.2 Dos Benchmark PCLabs

<b>Preparation</b>	<ul style="list-style-type: none"> <li>▶ Use chipDISK 92MB</li> <li>▶ Use Optimized Settings + USB enabled</li> <li>▶ Start MS-DOS Benchmark PC LABS</li> </ul>			
	Conduct all tests of the Performance, Compatibility and Quality menus and run Tests with following Settings			
<b>Flow</b>	Take following settings to climatic Chamber and Power Supply	<b>Climatic Conditions</b>	<b>Supply Voltage</b>	<b>Result</b>
		Room Temperature	Nominal Voltage	
		Room Temperature	10,8 V	
		-30°C	13,2 V	
	+60°C	Nominal Voltage	See following table	

### 10.2.1 Results


PC LABS Results			Nominal Voltage at Room Temp.	Nominal Voltage +10%	Nominal Voltage -10%	Nominal Voltage at +60°C	Nominal Voltage at -30°C
SYS	1	CPU	80486	80486	80486	80486	80486
SYS	2	CPU Speed	N/A	N/A	N/A	N/A	N/A
PROCSR	0	Processor Performance Tests					
PROCSR	1	Instruction Mix - 8088	0.02	0.02	0.01	0.02	0.01
PROCSR	2	Instruction Mix - 80286	0.01	0.01	0.02	0.01	0.01
PROCSR	3	Instruction Mix - 80386	0.01	0.01	0.01	0.01	0.02
PROCSR	4	Instruction Mix - 80486	0.02	0.01	0.01	0.01	0.01
PROCSR	5	128K NOP Loop	0.01	0.01	0.01	N/A	0.01
PROCSR	6	Do-nothing Loop	N/A	N/A	0.01	N/A	N/A
PROCSR	7	Integer Add	N/A	N/A	N/A	N/A	N/A
PROCSR	8	Integer Multiply	0.01	0.01	N/A	N/A	N/A
PROCSR	9	String Sort and Move	0.02	0.01	0.01	0.01	0.01
PROCSR	10	Prime Number Sieve	0.01	N/A	N/A	N/A	N/A
PROCSR	11	Floating Point Mix	0.06	N/A	0.05	N/A	N/A
COPROC	0	Coprocessor Performance Tests					

COPROC	1	Math Coprocessor Type	80486	80486	80486	80486	80486
COPROC	2	Math Coprocessor Mix	N/A	N/A	N/A	N/A	N/A
VIDEO	0	Video Performance Tests					
VIDEO	1	Direct Screen Access	0.28	0.22	0.22	0.22	0.22
VIDEO	2	Direct Screen Access	0.11	0.11	0.11	0.16	0.17
VIDEO	3	Direct Screen Access	0.44	0.44	0.43	0.39	0.39
MEMORY	0	Memory Performance Tests					
MEMORY	1	Conventional (Avg.)	N/A	N/A	0.03	N/A	N/A
MEMORY	2	Conventional Read	N/A	N/A	N/A	N/A	N/A
MEMORY	3	Conventional Write	N/A	N/A	0.05	N/A	N/A

## 10.3 Windows Benchmark Winbench99

<b>Preparation</b>	For comparison purposes always use <ul style="list-style-type: none"> <li>▶ 64MB SDRAM modul &gt;&gt; <b>256MB modul used !</b></li> <li>▶ IDE HDD Seagate 10GB ST310211A &gt;&gt; <b>Seagate ST32001A !</b></li> </ul>
	Test 1: Use BIOS <b>Fail Safe</b> Settings
	Test 2: Use BIOS <b>Optimized</b> Settings
<b>Flow</b>	<ul style="list-style-type: none"> <li>▶ Start Win98 and Winbench 99</li> <li>▶ Conduct following Tests in Winbench 99 Test Suite Selection <ol style="list-style-type: none"> <li>1. CPUmark32</li> <li>2. DirectDraw Tests</li> <li>3. FPU WinMark</li> <li>4. Processor Tests</li> </ol> </li> </ul>
<b>Result</b>	See following table

### 10.3.1 Results

	<b>Test1 BIOS FailSafe Settings used</b>	<b>Test2 BIOS Optimized Settings used</b>
Version	2000 Build 21	2000 Build 21
CPU Name	Intel(R) Pentium(R) 4 CPU 2.40GHz	Intel(R) Pentium(R) 4 CPU 2.40GHz
CPU Family	15	15
CPU Model	2	2
CPU Stepping	4	4
CPU Features	0x3FEBF9FF	0x3FEBF9FF
CPU Clock Speed	2400	2400
CPU L1 Cache (KB)	20	20
CPU L2 Cache (KB)	512	512
CPU Supports MMX	Yes	Yes
CPU Floating Point	Yes	Yes
System Name (Make/Model)	Unknown	Unknown
System BIOS Information	Phoenix	Phoenix
System BIOS Version	Phoenix - AwardBIOS v6.00PG	Phoenix - AwardBIOS v6.00PG
System Bus Type	Unknown	Unknown
System RAM (MB)	248	248
Display Adapter Name (Make/Model)	Intel(R) 82845G Graphics Controller	Intel(R) 82845G Graphics Controller
Display Adapter Chip	Unknown	Unknown
Display Adapter DAC	Unknown	Unknown
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Display Adapter Driver File(s) \tFile\tVersion\tDescription\tSize\tDate\tTime\n	Unknown	Unknown
Display Adapter Memory (KB)	Unknown	Unknown
Display Adapter BIOS Information	Unknown	Unknown
Display Color Reproduction	Unknown	Unknown
Display Cursor Type	Unknown	Unknown
Display Mode	1024 x 768 32 bits/pixel	1024 x 768 32 bits/pixel
Display Orientation	Landscape	Landscape
Display Refresh Rate (Hz)	Unknown	Unknown
Display Refresh Mode	Unknown	Unknown
Disk Name (Make/Model)	GENERIC IDE DISK TYPE00	GENERIC IDE DISK TYPE00
Disk Controller (Make/Model)	Intel(R) 82801DB Ultra ATA Storage Controller - 24CB	Intel(R) 82801DB Ultra ATA Storage Controller - 24CB
Disk Controller RAM (KB)	Unknown	Unknown
Disk Windows Cache Type	System Cache: write caching enabled	System Cache: write caching enabled
Disk Windows Cache RAM (KB)	All Available RAM	All Available RAM
Disk Settings Synchronous buffer commits disabled	No	No
Disk Settings Write-behind caching for all drives disabled	No	No
Disk Settings 32 bit protect-mode disk drivers disabled	No	No
Disk Settings Long name preservation for old programs disabled	No	No
Disk Settings New file sharing and locking semantics disabled	No	No
Disk Settings Protect-mode hard disk interrupt handling disabled	No	No
APM Battery Life	Unknown	Unknown
APM BIOS Information	Unknown	Unknown
APM Enabled	Yes	Yes
APM AC Power	Yes	Yes
CD-ROM Name (Make/Model)	ASUS CD-S500/A	ASUS CD-S500/A
CD-ROM Controller (Make/Model)	Unknown	Unknown
CD-ROM Controller RAM (KB)	Unknown	Unknown
CD-ROM Windows Cache Type	CDFS Cache	CDFS Cache
CD-ROM Windows Cache RAM (KB)	1238 KB	1238 KB
Sound Adapter Name (Make/Model)	Gameport Joystick	Gameport Joystick
Sound Adapter Driver	Unknown	Unknown
Windows Computer Name	886LCD_ATX	886LCD_ATX
Windows Version	Windows 98 Second Edition, Build 2222 A	Windows 98 Second Edition, Build 2222 A
Display Adapter Driver Acceleration	0x 0	0x 0
Display Refresh Pattern	Unknown	Unknown
Disk Settings Read Ahead Threshold	65536	65536
Disk Settings Path Cache	Default	Default
Disk Settings Name Cache	Default	Default
Disk Settings CDFS Prefetch	228	228
Disk Settings CDFS Prefetch Tail	128	128
CPU Active Processors	1	1
CPU Clock Speed (Unrounded)	2393157886	2393095887

CPU Supports 3DNow!	No		No
Display Devices	Unknown		Unknown
CPU Supports Streaming SIMD	Yes		Yes
CPU L3 Cache (KB)	0		0
QueryPerformanceFrequency	1193180		1193180
<b>WEIGHTED SUITE</b>	<b>SCORE</b>	<b>UNITS</b>	<b>SCORE</b>
CPUmark32	4610		4580
FPU WinMark	8360		8360
<b>TEST</b>			
DirectDraw/Animate Screen Size, 640x480:Pixels Drawn	821	Million Pixels/Sec	818
DirectDraw/Animate Screen Size, 800x600:Pixels Drawn	725	Million Pixels/Sec	720
DirectDraw/Animate Screen Size, 1024x768:Pixels Drawn	796	Million Pixels/Sec	788
DirectDraw/Animate Screen Size, 1152x864:Pixels Drawn	758	Million Pixels/Sec	752
DirectDraw/Animate Screen Size, 1280x1024:Pixels Drawn	762	Million Pixels/Sec	763
DirectDraw/Animate Screen Size, 1600x1200:Pixels Drawn	689	Million Pixels/Sec	No Result
DirectDraw/Animate Color Depth, 8 bit:Pixels Drawn	820	Million Pixels/Sec	818
DirectDraw/Animate Color Depth, 16 bit:Pixels Drawn	349	Million Pixels/Sec	346
DirectDraw/Animate Color Depth, 24 bit:Pixels Drawn	No Result	Million Pixels/Sec	No Result
DirectDraw/Animate Color Depth, 32 bit:Pixels Drawn	199	Million Pixels/Sec	194
DirectDraw/Animate BltFast:Pixels Drawn	820	Million Pixels/Sec	818
DirectDraw/Animate Blt:Pixels Drawn	820	Million Pixels/Sec	817
DirectDraw/Animate Solid:Pixels Drawn	638	Million Pixels/Sec	636
DirectDraw/Animate Transparent:Pixels Drawn	786	Million Pixels/Sec	782
DirectDraw/Animate Full Screen:Pixels Drawn	185	Million Pixels/Sec	175
DirectDraw/Animate Windowed:Pixels Drawn	174	Million Pixels/Sec	164
DirectDraw/Animate Clipped:Pixels Drawn	183	Million Pixels/Sec	173
DirectDraw/Animate Memory, Source in video, Work area in video:Pixels Drawn	820	Million Pixels/Sec	818
DirectDraw/Animate Memory, Source in system, Work area in video:Pixels Drawn	510	Million Pixels/Sec	510
DirectDraw/Animate Memory, Source in video, Work area in system:Pixels Drawn	15,6	Million Pixels/Sec	15. Jul
DirectDraw/Animate Memory, Source in system, Work area in system:Pixels Drawn	1220	Million Pixels/Sec	1220
DirectDraw/Animate BLT size, 256 pixels:Pixels Drawn	217	Million Pixels/Sec	225

DirectDraw/Animate BLT size, 1024 pixels:Pixels Drawn	583	Million Pixels/Sec	581
DirectDraw/Animate BLT size, 4096 pixels:Pixels Drawn	820	Million Pixels/Sec	818
DirectDraw/Animate Stretch, Solid, 2.0x, 8 bit:Pixels Drawn	36,9	Million Pixels/Sec	37
DirectDraw/Animate Stretch, Solid, 1.7x, 8 bit:Pixels Drawn	6,95	Million Pixels/Sec	Jun 95
DirectDraw/Animate Stretch, Transparent, 1.7x, 8 bit:Pixels Drawn	6,98	Million Pixels/Sec	Jun 98
DirectDraw/Animate Stretch, Solid, 1.7x, 16 bit:Pixels Drawn	179	Million Pixels/Sec	178
DirectDraw/Animate Stretch, Solid, 1.7x, 24 bit:Pixels Drawn	No Result	Million Pixels/Sec	No Result
DirectDraw/Animate Stretch, Solid, 1.7x, 32 bit:Pixels Drawn	89,7	Million Pixels/Sec	88
DirectDraw/Fill Color Depth, 8 bit color:Pixels Drawn	1430	Million Pixels/Sec	1430
DirectDraw/Fill Color Depth, 16 bit color:Pixels Drawn	680	Million Pixels/Sec	672
DirectDraw/Fill Color Depth, 24 bit color:Pixels Drawn	No Result	Million Pixels/Sec	No Result
DirectDraw/Fill Color Depth, 32 bit color:Pixels Drawn	344	Million Pixels/Sec	336

## 10.4 Graphics Performance

### 10.4.1 Signal Measurements

<b>Test Flow</b>	<ul style="list-style-type: none"> <li>▶ Attach Monitor Samtron 75E</li> <li>▶ Set resolution to 1024x768 and Color depth to 32 bit</li> <li>▶ Start Kontron graphics testtool rgbspots.exe</li> <li>▶ Measure voltage level and signal rise time on RGB lines with oscilloscope</li> </ul>		
<b>Result</b>	Voltage Level R / G / B	in mV	<b>510 / 492 / 474</b>
	Signal Rise Time R / G / B	in ns	<b>8,01 / 15,49 / 10,31</b>

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**Screenshots**

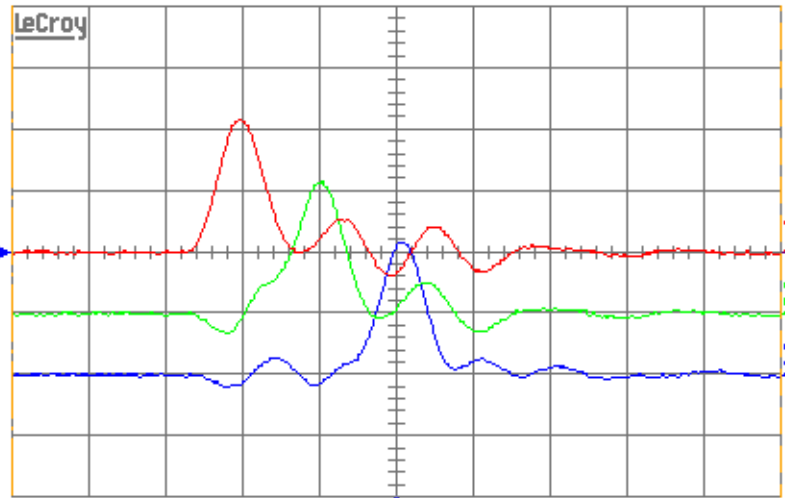
27-Jan-03  
12:44:35

Reading Floppy Disk Drive

1  
20 ns  
200mV

2  
20 ns  
200mV

3  
20 ns  
200mV



	232 sweeps:	average	low	high	sigma
pkpk (1)		510mV	500	519	4
pkpk (2)		492mV	481	500	4
pkpk (3)		474mV	469	481	4

20 ns

- 1 .2 V DC
- 2 .2 V DC
- 3 .2 V DC
- 4 50 mV AC



3 DC 0.400 V

2 GS/s

STOPPED

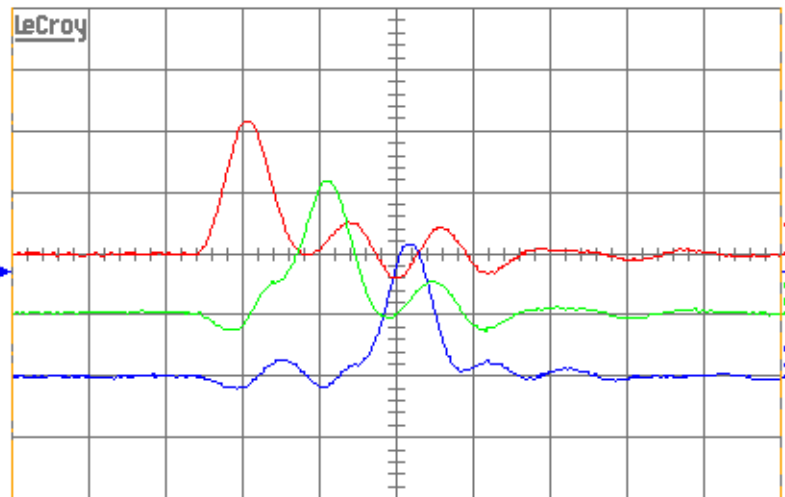
27-Jan-03  
12:46:58

Reading Floppy Disk Drive

2  
20 ns  
200mV

1  
20 ns  
200mV

3  
20 ns  
200mV



	315 sweeps:	average	low	high	sigma
rise(1)		8.01 ns	7.42	9.81	0.21
rise(2)		15.49 ns	14.84	18.13	0.66
rise(3)		10.31 ns	9.35	11.82	0.46

20 ns

- 1 .2 V DC
- 2 .2 V DC
- 3 .2 V DC
- 4 50 mV AC



3 DC 0.344 V

2 GS/s

STOPPED

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## 10.4.2 DOS

<b>Test Flow</b>	<ul style="list-style-type: none"> <li>▶ Run testscreen.exe</li> <li>▶ Run all tests in the Graphics Tab of AMIDdiag <ul style="list-style-type: none"> <li>Video Memory Test</li> <li>Attribute Test</li> <li>Page Selection Test</li> <li>Color Test</li> <li>Text Mode Test</li> <li>Graphics Mode Test</li> <li>VESA Video Modes Test</li> <li>AGP Test</li> </ul> </li> </ul>
<b>Result</b>	<b>X</b> <b>Test passed successfully</b>
	<b>Test failed because</b>
	<b>Test skipped because</b>

## 10.4.3 Winbench Graphic Marks

<b>Test Flow</b>	<ul style="list-style-type: none"> <li>▶ Set Display mode: <ul style="list-style-type: none"> <li>Resolution : max : 1024x786</li> <li>Color depth : max: True Color (32-Bit)</li> </ul> </li> <li>▶ Run <ul style="list-style-type: none"> <li>Winbench Business Graphics Mark</li> <li>Winbench High-End Graphics Mark</li> </ul> </li> </ul>	
<b>Result</b>	Business Graphics Mark	<b>161</b>
	High-End Graphics	<b>1250</b>

## 10.4.4 Resolution / Color Depth

<b>Test Flow</b>	<ul style="list-style-type: none"> <li>▶ Set the three highest resolutions and three highest color depths / resolution: <div style="display: flex; align-items: center; margin-left: 20px;"> <div style="display: flex; flex-direction: column; gap: 5px;"> <div>800 x 600</div> <div>1024 x 768</div> <div>1280 x 1024</div> </div> <div style="font-size: 2em; margin: 0 10px;">}</div> <div>32-bit, 16-bit, 256 color</div> </div> </li> <li>▶ Play starwars.avi</li> </ul>
<b>Result</b>	<b>X</b> <b>Test passed successfully</b>
	<b>Test failed because</b>
	<b>Test skipped because</b>

## 10.5 HDD Performance

<b>Test Preparation</b>	<ul style="list-style-type: none"> <li>▶ Always use HDD Seagate ST310211A, 10GB, Ultra ATA/100 for comparison purposes</li> <li>▶ Verify with "ct Ampel"</li> </ul>	
<b>Additional CMOS Settings</b>		
<b>Menu</b>	<b>Setting</b>	
Load optimized Settings		
<b>Test Flow</b>	<ul style="list-style-type: none"> <li>▶ Run H2Bench</li> <li>▶ Run Business Disk Winmark</li> <li>▶ Run Highend Disk Winmark</li> </ul>	
<b>Result</b>	H2Bench	see result list below
	Business Disk Winmark	<b>3450</b>
	Highend Disk Winmark	<b>12800</b>

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**Result H2Bench:**

Platte: Seagate  
 BIOS: Award  
 CPU: INTEL P4 2.4 GHz  
 Board: ATX  
 Adapter: none

Kapazit,t: CHS=(1024/255/63), 16450560 Sektoren = 8033 MByte

Interface-Transferrate mit Blockgr"ae 128 Sektoren bei 0.0% der Kapazit,t:  
 Sequentielle Leserate Medium (ungebremst): 5142 KByte/s  
 Sequentielle Leserate Read-Ahead (Verz"gerung: 13.69 ms): 4991 KByte/s  
 Wiederholtes sequentielles Lesen ("Coretest"): 5370 KByte/s

Dauertransferrate (Blockgr"ae: 128 Sektoren):  
 Lesen: Mittel 5064.4, Min 4859.7, Max 5187.4 [KByte/s]

Zugriffszeit Lesen: Mittel 17.8, Min 3.2, Max 37.6 [ms]  
 Zugriffszeit Lesen (<504 MByte): Mittel 9.7, Min 1.7, Max 36.7 [ms]

Hdbench bei 0.0% der Kapazit,t:  
 Gewichteter Mittelwert 3280.6, Min 919.3, Max 5085.0 [KByte/s] [NUR LESEN]

Detailergebnisse:

```
-----
Nr. Bl. File WLin RLin WRan RRan WLin RLin WRan RRan
sz. size          Again Again Again
[KB] [KB] [KB/s] [KB/s] [KB/s] [KB/s] [KB/s] [KB/s] [KB/s] [KB/s]
1 0.5 50 ----- 1091.7 ----- 2303.3 ----- 2314.5 ----- 2321.7
2 1.0 100 ----- 3199.7 ----- 3222.6 ----- 3217.8 ----- 3249.4
3 2.0 200 ----- 3552.9 ----- 1250.1 ----- 3600.6 ----- 1384.7
4 4.0 400 ----- 3610.6 ----- 935.2 ----- 3604.7 ----- 919.3
5 8.0 800 ----- 4256.7 ----- 1313.4 ----- 4324.8 ----- 1263.3
6 16.0 1600 ----- 4369.4 ----- 1637.3 ----- 4143.0 ----- 1636.5
7 24.0 2400 ----- 3672.2 ----- 2161.9 ----- 3544.2 ----- 2160.3
8 32.0 3200 ----- 4727.5 ----- 2483.2 ----- 4645.7 ----- 2483.0
9 40.0 4000 ----- 3842.1 ----- 2811.7 ----- 4052.6 ----- 2880.3
10 48.0 4800 ----- 4234.2 ----- 3088.6 ----- 4066.4 ----- 3086.1
11 56.0 5600 ----- 4694.1 ----- 3199.5 ----- 4667.1 ----- 3190.3
12 62.0 6200 ----- 4995.5 ----- 3474.6 ----- 4963.6 ----- 3466.2
13 63.0 6300 ----- 5085.0 ----- 3531.5 ----- 5063.5 ----- 3544.1
14 63.5 6350 ----- 5014.5 ----- 3550.1 ----- 5058.1 ----- 3550.1

Maximum ----- 5085.0 ----- 3550.1 ----- 5063.5 ----- 3550.1
Mittel ----- 4024.7 ----- 2497.4 ----- 4090.5 ----- 2509.7
```

Max 5085.0 [KB/s], Min 919.3 [KB/s], gewichtetes Mittel 3280.6 [KB/s]

Timerauff"sung: 0.838 æs, 1.193 MHz  
 Timerstatistik: 5241 Aufrufe, min 1744.08 æs, mittel 329914.31 æs, max 1788683.54 æs  
 Testbeginn: 29.01.03 01:34:41  
 Testversion: \$Id: h2bench.c,v 2.26 1999/01/20 13:29:41 hwb Exp \$  
 Kommandozeile: A:\H2BENCH.EXE -a -w h2bench 0

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## 10.6 Network Performance

### 10.6.1 General Conditions

- 50m 100BaseT cable
- Crossed 100BaseT Ethernet patch cable

Additional CMOS Settings	
Menu	Setting
Set Optimized Settings	

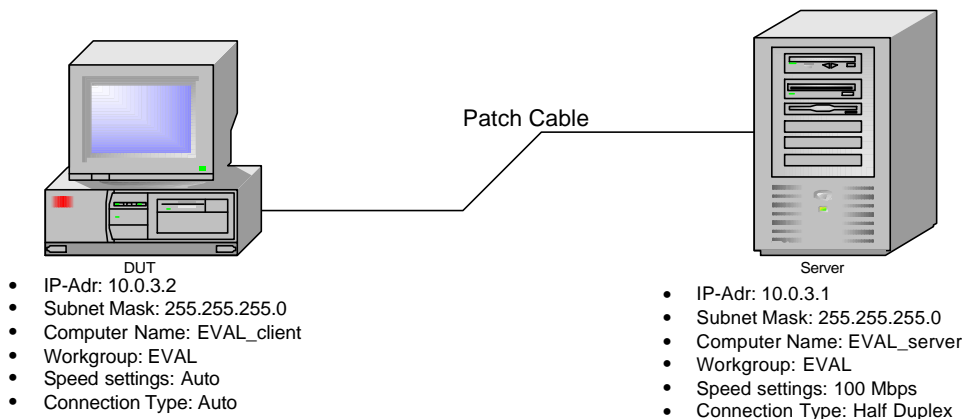
Additional used Hardware	
Device	Register Code
Approval Server	
Oscilloscope LT374; differential probe	
10BaseT Hub	EA0276
Ethernet measurement adapter 10BaseT	EA0239

Additional used Software	
Windows 98	
Netio.exe	

### 10.6.2 Patch Cable Test

#### 10.6.2.1 Patch Cable Test Preparation

Connect DUT and Eval\_Server via a crossed 100BaseT Ethernet patch cable.



#### 10.6.2.2 Patch Cable Test Flow

1. Search the network and assure to have access to the Eval\_Server by copying the directory <\software> from the Server to the DUT.
2. Run netio.exe in Server mode (netio.exe -s) on the Eval\_Server. Run netio.exe in Client mode (netio.exe -t 10.0.3.1) on the DUT and evaluate the benchmark results at various packet sizes. Insert the results in tables as shown in the following.

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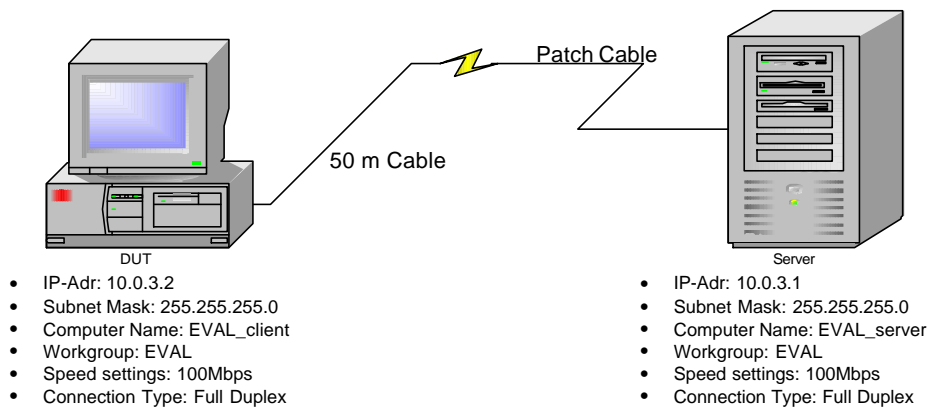
### 10.6.2.3 Patch Cable Test Result

TCP/IP connection established.		NetBIOS connection established.	
1k packets:	9897 k/sec	1k packets:	4589 k/sec
2k packets:	8734 k/sec	2k packets:	6971 k/sec
4k packets:	10219 k/sec	4k packets:	8474 k/sec
8k packets:	9833 k/sec	8k packets:	3396 k/sec
16k packets:	3372 k/sec	16k packets:	3582 k/sec
32k packets:	163 k/sec	32k packets:	9023 k/sec

## 10.6.3 Long Distance Cable Test

### 10.6.3.1 Long Distance Cable Test Preparation

Connect DUT and Eval\_Server via a 100BaseT Ethernet cable with a length of 50m and a crossed 100BaseT Ethernet patch cable.



### 10.6.3.2 Long Distance Cable Test Flow

Repeat steps 1 and 2 of the Patch Cable Test.

### 10.6.3.3 Long Distance Cable Test Result

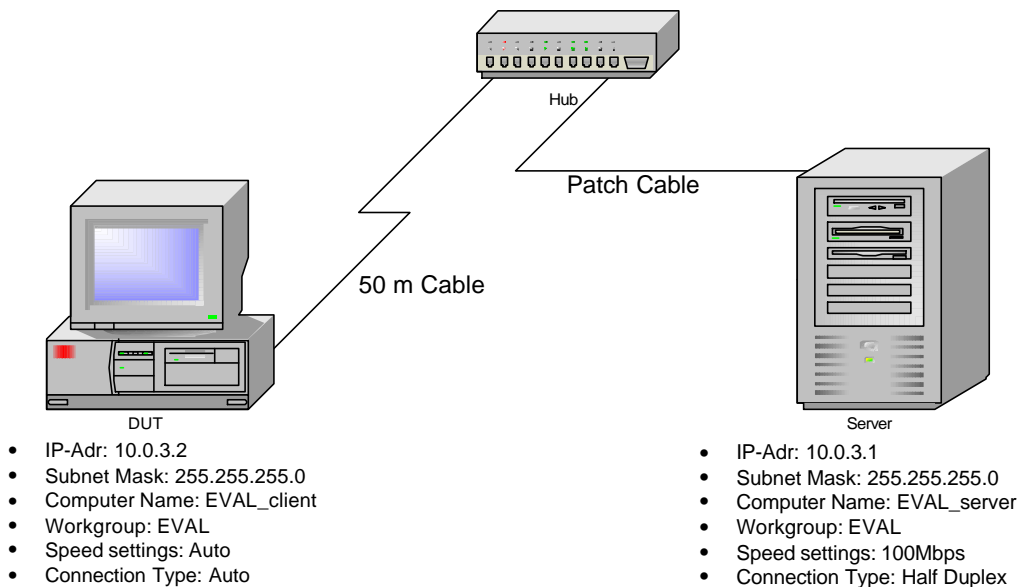
TCP/IP connection established.		NetBIOS connection established.	
1k packets:	10466 k/sec	1k packets:	5335 k/sec
2k packets:	8298 k/sec	2k packets:	5898 k/sec
4k packets:	9195 k/sec	4k packets:	7618 k/sec
8k packets:	11317 k/sec	8k packets:	7972 k/sec
16k packets:	10304 k/sec	16k packets:	9145 k/sec
32k packets:	160 k/sec	32k packets:	10695 k/sec

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## 10.6.4 Hub Test

### 10.6.4.1 Hub Test Preparation

Connect DUT and Eval\_Server via a hub, 50m 100BaseT cable and a crossed 100BaseT Ethernet patch cable.



### 10.6.4.2 Hub Test Flow

Repeat steps 1 and 2 of the patch cable test.

### 10.6.4.3 Result Hub Test

TCP/IP connection established.	NetBIOS connection established.
1k packets: 5719 k/sec	1k packets: 3183 k/sec
2k packets: 7566 k/sec	2k packets: 4727 k/sec
4k packets: 8479 k/sec	4k packets: 6646 k/sec
8k packets: 8305 k/sec	8k packets: 4522 k/sec
16k packets: 6209 k/sec	16k packets: 4764 k/sec
32k packets: 167 k/sec	32k packets: 8047 k/sec

## 10.7 Sound Test

Additional used Hardware	
Device	Register Code
Sound Connector Terminations	Line Out: 40 kOhm Headphone: 92Ohm Speaker: 8 Ohm
Active Loudspeaker	EA0175
Oszilloscope Waverunner2 LT374	LeCroy
Function Generator HM 8130	Hameg

Additional used Software	
Windows 98	
Audiotester V1.4	

The sound measurements, as described below, do not put a claim to be exact professional audio measurements. The values listed in the report are only clues to prequantify sound behaviour. So do not compare these values to measurements with high quality audio measurements equipment. The mentioned measurements are rather for comparison purposes with other Kontron Embedded Boards in order to find out whether there is something wrong with sound input / output in general.

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## 10.7.1 General Settings

General Driver Settings	
System Control → Multimedia → Audio Quality	
Hardware Acceleration: max	
Sample Converting Quality: max	

## 10.7.2 Sound Test subjective (Mic In)

Record voice via microphone and playback sampled recordings. Set Mic In / Master Volume at Win98 Mixer to ≈70% (→ -3dB).

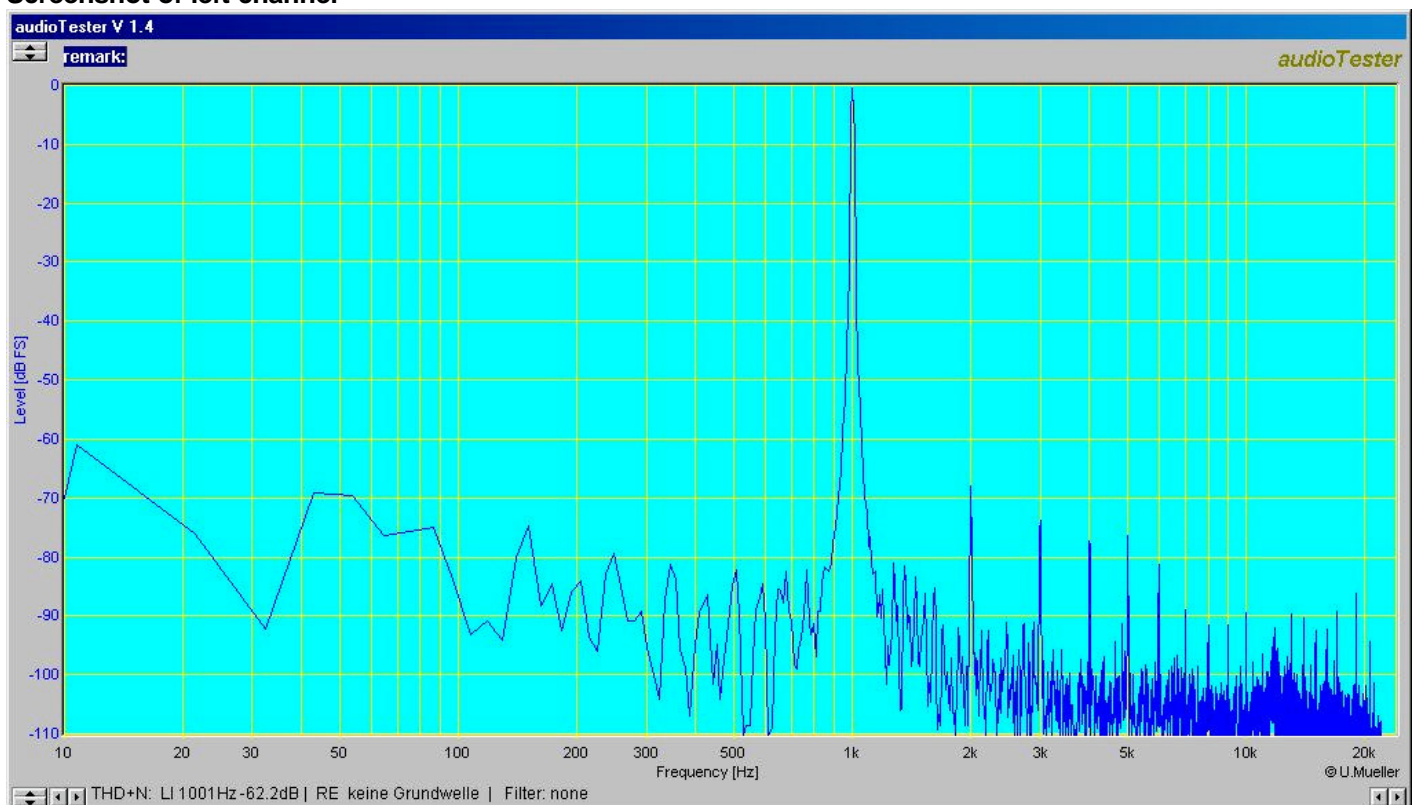
### Result:

X	Test passed successfully
	Test skipped because
	Test failed because

## 10.7.3 Sound Input (Line In)

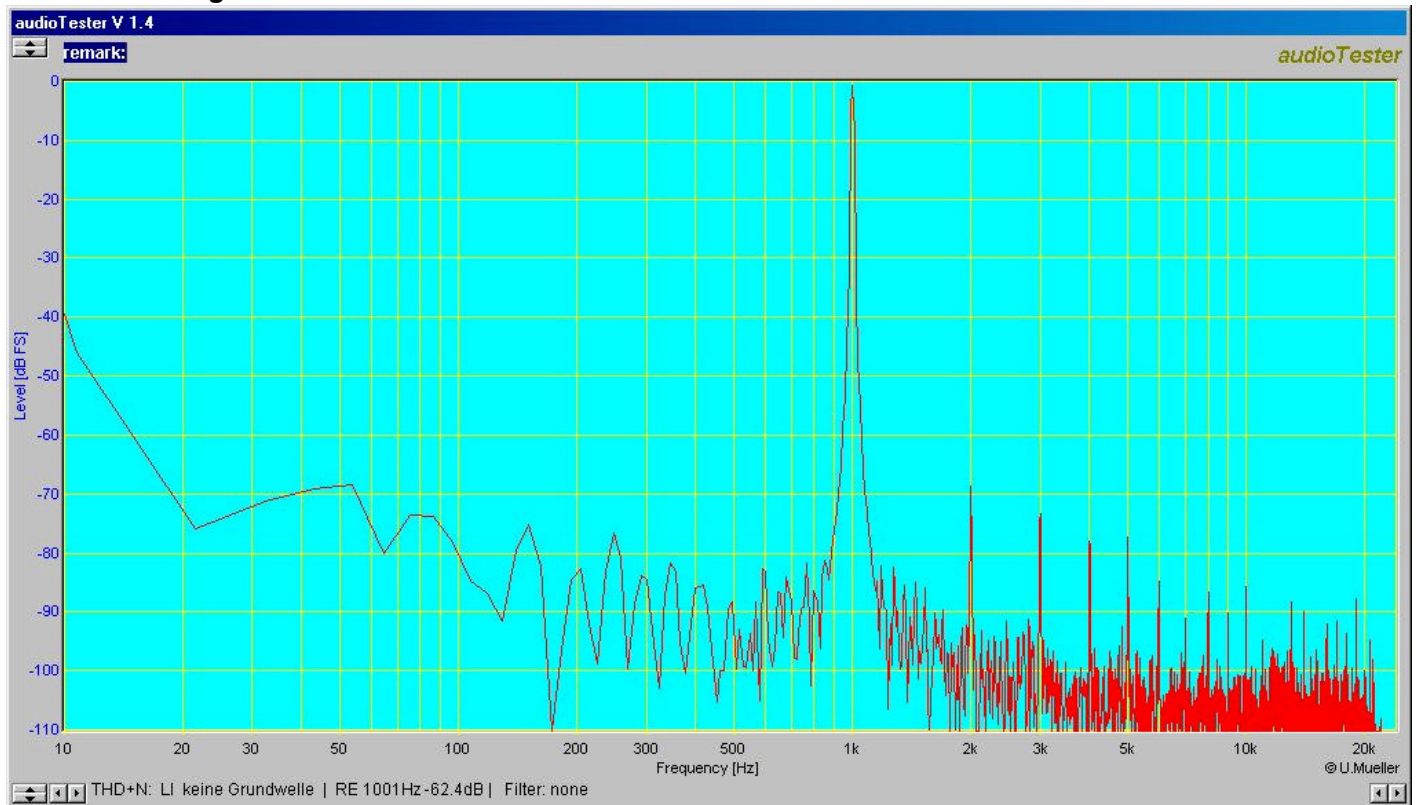
<b>Test Preparation</b>	<ul style="list-style-type: none"> <li>▶ Set Line In Volume at WIN98 Mixer to 100%, all other inputs are disabled</li> <li>▶ Connect LINE input via adapter with Function Generator with following Settings: Sine Frequ.: 1 kHz; Amplitude: set amplitude as high as possible so that just no clipping appears (no red beams may appear in volume control) Adjusted Amplitude: <b>84,6 mV<sub>RMS</sub></b></li> </ul>
<b>Test Flow</b>	<ul style="list-style-type: none"> <li>▶ Start AudioTester V1.4 and set recording amplitude to -3dBFS.</li> <li>▶ Set von Hann Filter</li> <li>▶ Record sound input</li> <li>▶ Start FFT Analysis and insert screenshot into the test report.</li> <li>▶ Measure THD+N with Audio Tester</li> </ul>

### Screenshot of left channel



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## Screenshot of right channel



## Result:

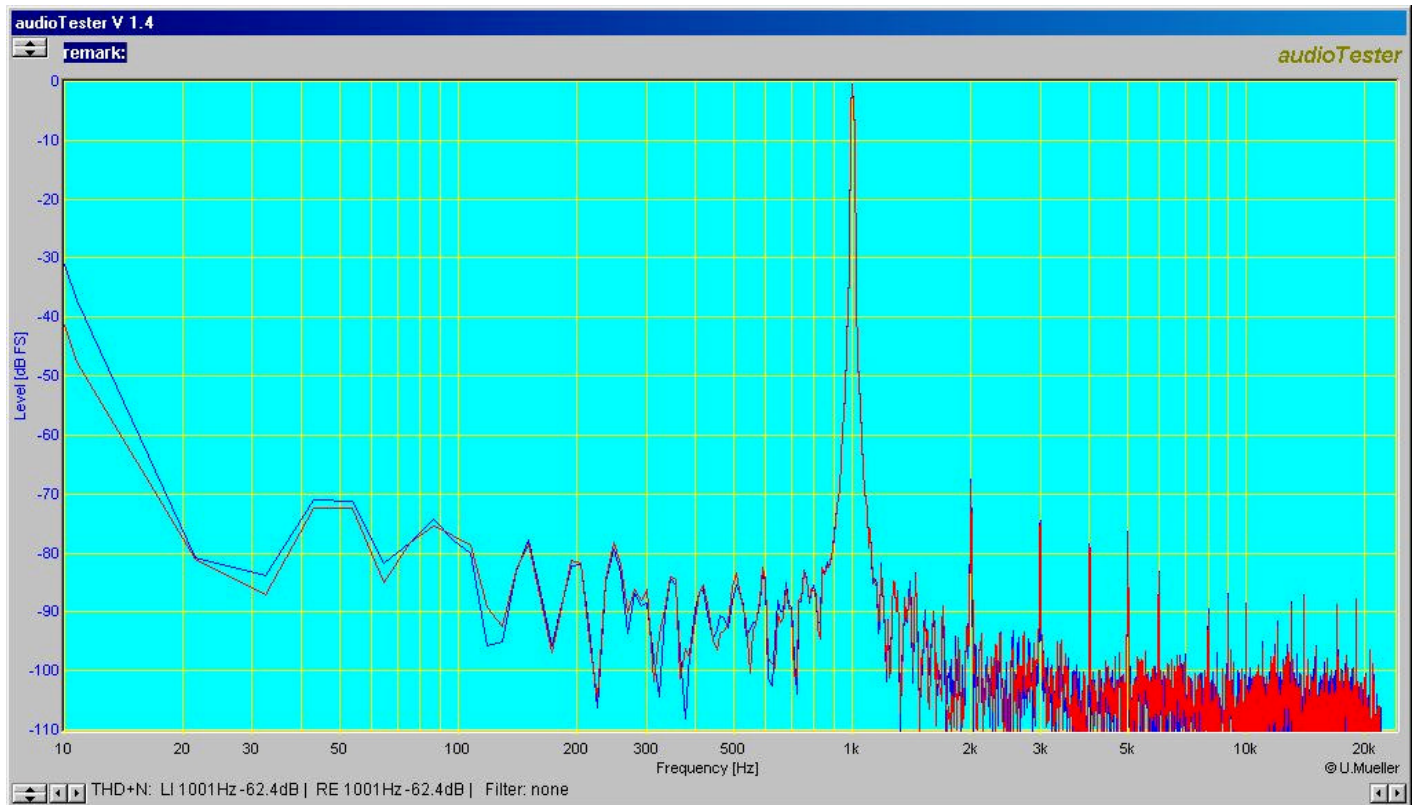
	<b>Test passed successfully</b>	
X	THD+N with Audio Tester (Line In Left Channel )	- 62,2 dB
	THD+N with Audio Tester (Line In Right Channel )	- 62,4 dB
	<b>Test skipped because</b>	
	<b>Test failed because</b>	

## 10.7.4 Sound Input (MIC In)

<b>Test Preparation</b>	<ul style="list-style-type: none"> <li>▶ Set Mic In Volume at WIN98 Mixer to 100%, all other inputs are disabled.</li> <li>▶ Connect MIC input via adapter with Function Generator with following Settings: Sine Frequ.: 1 kHz; Amplitude: set amplitude as high as possible so that just no clipping appears (no red beams may appear in volume control) Adjusted Amplitude: <b>95,1 mV<sub>RMS</sub></b></li> </ul>
<b>Test Flow</b>	<ul style="list-style-type: none"> <li>▶ Start AudioTester V1.4 and set recording amplitude to -3dBFS.</li> <li>▶ Set von Hann Filter</li> <li>▶ Record sound input</li> <li>▶ Start FFT Analysis and insert screenshot into the test report.</li> <li>▶ Measure THD+N with Audio Tester</li> </ul>

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## Screenshot MIC In



## Result:

	<b>Test passed successfully</b>	
X	<b>THD+N with Audio Tester (Mic In)</b>	<b>- 62,4 dB</b>
	<b>Test skipped because</b>	
	<b>Test failed because</b>	

## 10.7.5 Sound output (Line Out)

<b>Test Preparation</b>	<ul style="list-style-type: none"> <li>▶ Start sinusgen.exe with following Settings:            Frequ.: 1 kHz            Outp. Amplitude: 0 dB</li> <li>▶ Connect Line Out (left and right channel) via termination adapter to oscilloscope</li> <li>▶ Set Master Volume at WIN98 Mixer to -3dBFS (=70% of max Amplitude at 0dB)</li> <li>▶ Prepare Oscilloscope</li> </ul>
<b>Test Flow</b>	<ul style="list-style-type: none"> <li>▶ Start FFT analysis with von Hann filter and show results in magnitude mode; insert screenshot into the test report</li> <li>▶ Measure <math>V_{RMS}</math> of 0dBFS on both channels</li> <li>▶ Repeat measurements with following settings of sinusgen.exe            Frequ.: 10 kHz            Outp. Vol. (sinusgen.exe): 0 dB</li> </ul>

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**Screenshot Right Channel 1KHz**

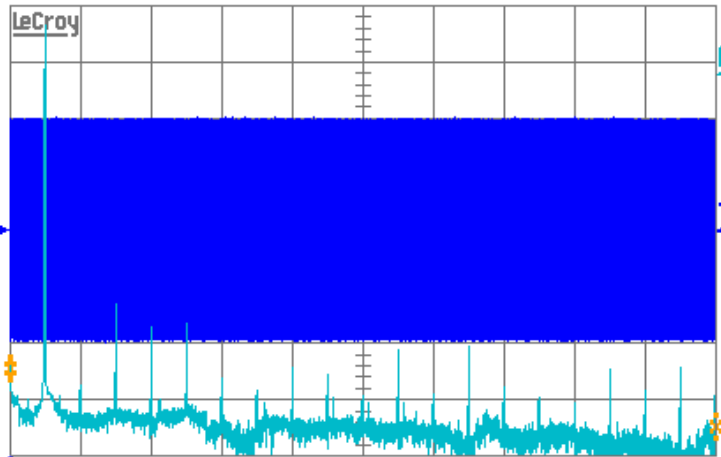
27-Jan-03

Reading Floppy Disk Drive

17:16:39

PS(AVGP(B)  
2 kHz  
11.0 dBm  
====86 swps

50 ms  
0.50 V



43 sweeps:				
	average	low	high	sigma
pkpk(A)	87.1 dBm	72.0	91.3	4.2
mean(A)	-68.96 dBm	-69.45	-61.99	1.20
sdev(A)	3.56 dBm	1.50	3.93	0.44
rms(A)	69.05 dBm	62.00	69.55	1.22
ampl(A)	79.0 dBm	72.2	81.6	1.3

50 ms

- 1 .5 V 500Ω
- 2 trig only
- 3 2 mV AC
- 4 trig only



1 HFREJ 0.01 V

200 kS/s

STOPPED

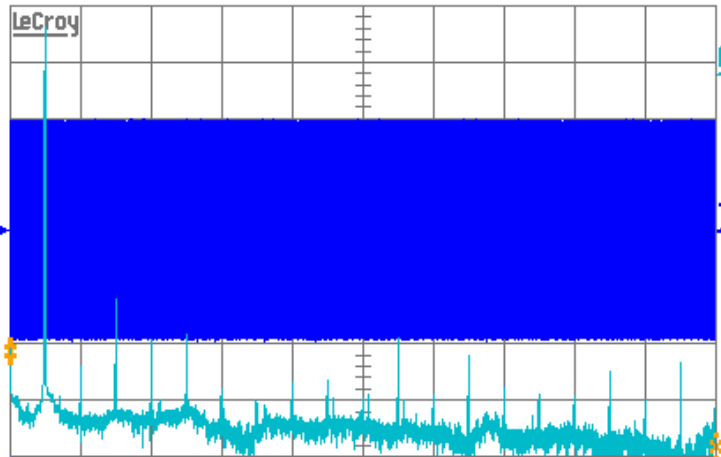
**Screenshot Left Channel 1KHz**

27-Jan-03

17:30:40

PS(AVGP(B)  
2 kHz  
11.0 dBm  
====86 swps

50 ms  
0.50 V



44 sweeps:				
	average	low	high	sigma
pkpk(A)	86.8 dBm	71.9	91.2	4.4
mean(A)	-68.84 dBm	-69.37	-61.98	1.28
sdev(A)	3.49 dBm	1.50	3.90	0.45
rms(A)	68.93 dBm	62.00	69.47	1.30
ampl(A)	78.8 dBm	72.1	82.1	1.4

50 ms

- 1 .5 V 500Ω
- 2 trig only
- 3 2 mV AC
- 4 trig only



1 HFREJ 0.01 V

200 kS/s

STOPPED

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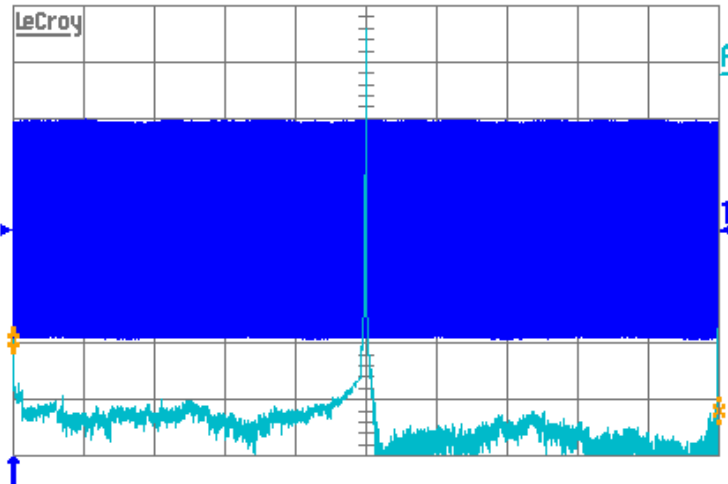
**Screenshot Right Channel 10Khz**

27-Jan-03

17:26:56

PS(AVGP(B)  
2 kHz  
11.0 dBm  
====81 swps

50 ms  
0.50 V



	42 sweeps: average	low	high	sigma
pkpk(A)	86.2 dBm	71.4	90.5	4.4
mean(A)	-68.30 dBm	-68.78	-61.78	1.26
sdev(A)	4.56 dBm	2.16	4.88	0.56
rms(A)	68.46 dBm	61.82	68.95	1.29
ampl(A)	78.0 dBm	71.6	81.0	1.4

50 ms

- 1 .5 V 500Ω
- 2 trig only
- 3 2 mV AC
- 4 trig only



1 HFREJ 0.01 V

200 kS/s

STOPPED

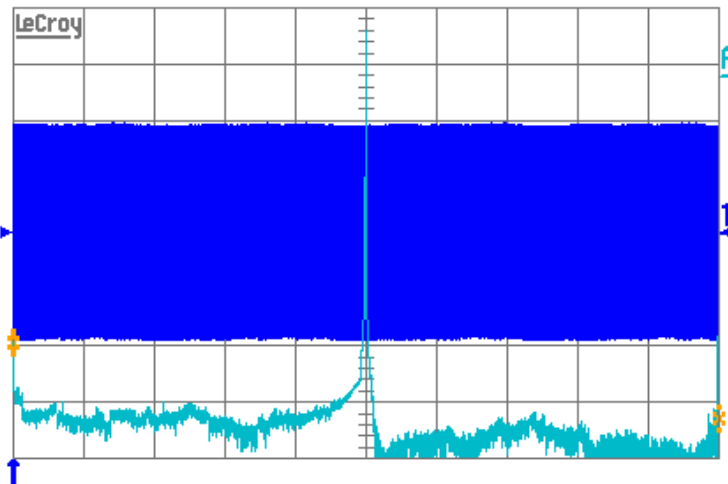
**Screenshot Left Channel 10Khz**

27-Jan-03

17:28:51

PS(AVGP(B)  
2 kHz  
11.0 dBm  
====83 swps

50 ms  
0.50 V



	42 sweeps: average	low	high	sigma
pkpk(A)	86.3 dBm	71.3	90.5	4.2
mean(A)	-68.37 dBm	-68.78	-61.79	1.15
sdev(A)	4.56 dBm	2.15	4.86	0.52
rms(A)	68.53 dBm	61.83	68.95	1.18
ampl(A)	77.8 dBm	71.5	80.3	1.2

50 ms

- 1 .5 V 500Ω
- 2 trig only
- 3 2 mV AC
- 4 trig only



1 HFREJ 0.01 V

200 kS/s

STOPPED

**Result:**

X	Test passed successfully
	Test skipped because
	Test failed because

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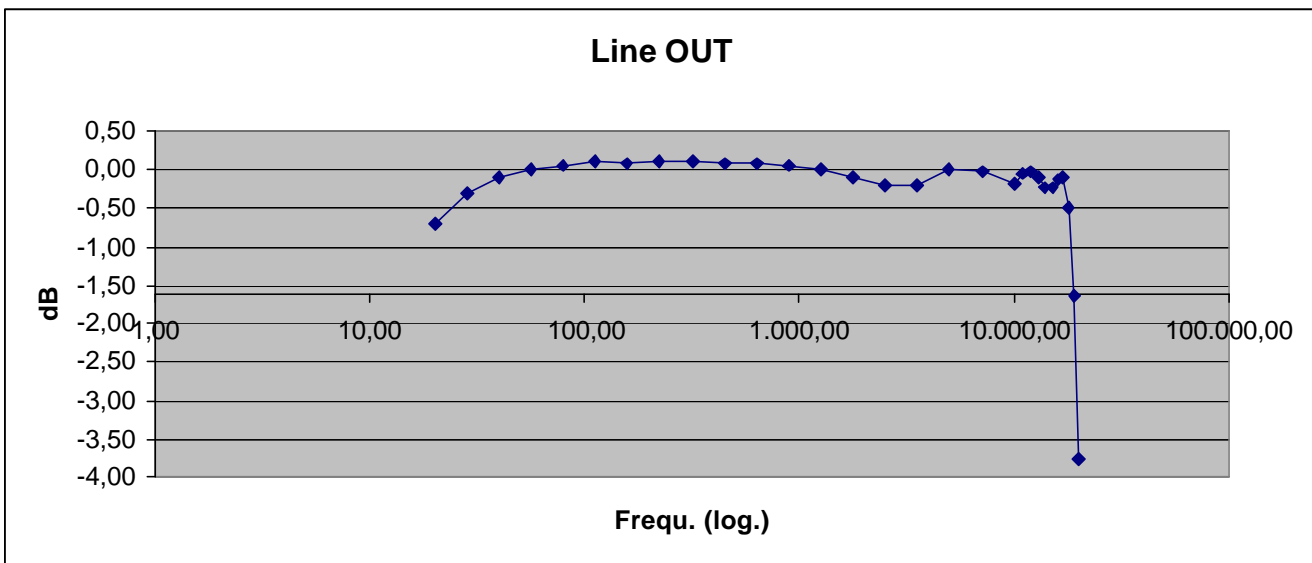
### 10.7.6 Frequency Response Record and Playback Path

#### 10.7.6.1 Playback Path

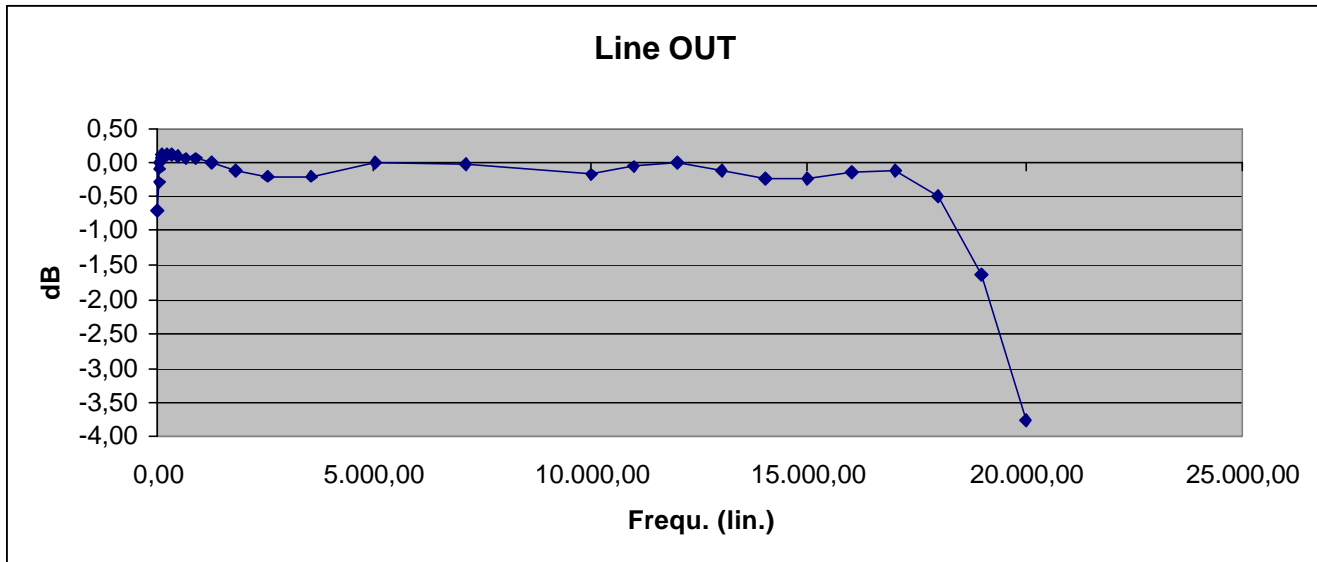
<b>Test Preparation</b>	<ul style="list-style-type: none"> <li>▶ Connect Line In with Function Generator</li> <li>▶ Connect Line Out via termination adapter with Oscilloscope</li> <li>▶ Set Master Volume at WIN98 Mixer to 0dB (=100% )</li> <li>▶ Prepare Oscilloscope</li> </ul>
<b>Test Flow</b>	<ul style="list-style-type: none"> <li>▶ Generate 1kHz Sine with Function Generator, adjust amplitude to -20dB to minimize distortion; Use that measured level as 0dB reference; Sweep frequencies from 20Hz...20kHz</li> </ul>
<b>Result</b>	see tables and diagrams below

Results Line Out						
Freq [Hz]	RMS Voltage Level [mV]	Level [dB] relative to 1kHz *		Freq [Hz]	RMS Voltage Level [mV]	Level [dB] relative to 1kHz *
20,00	756	-0,69		3.556,60	800	-0,19
28,30	790	-0,30		5.023,80	818	0,00
39,90	809	-0,10		7.096,30	815	-0,03
56,40	818	0,00		10.000,00	801	-0,18
79,60	824	0,06		11.000,00	813	-0,05
112,50	828	0,11		12.000,00	817	-0,01
158,90	827	0,10		13.000,00	808	-0,11
224,40	828	0,11		14.000,00	796	-0,24
317,00	828	0,11		15.000,00	796	-0,24
447,70	827	0,10		16.000,00	806	-0,13
632,50	825	0,07		17.000,00	808	-0,11
893,40	823	0,05		18.000,00	773	-0,49
1.261,90	818	0,00		19.000,00	678	-1,63
1.782,50	808	-0,11		20.000,00	530	-3,77
2.517,90	800	-0,19				

- Formula:  $20 \log (\text{Level}[\text{mV}] / \text{Level}@1\text{kHz}[\text{mV}])$



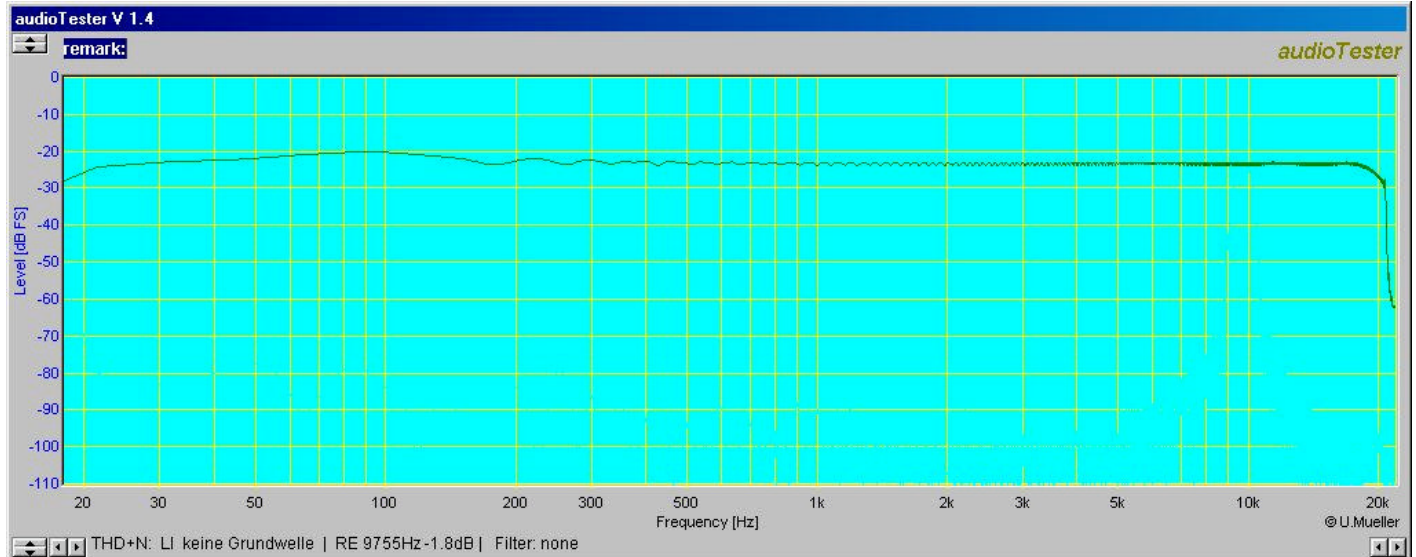
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### 10.7.6.2 Record Path

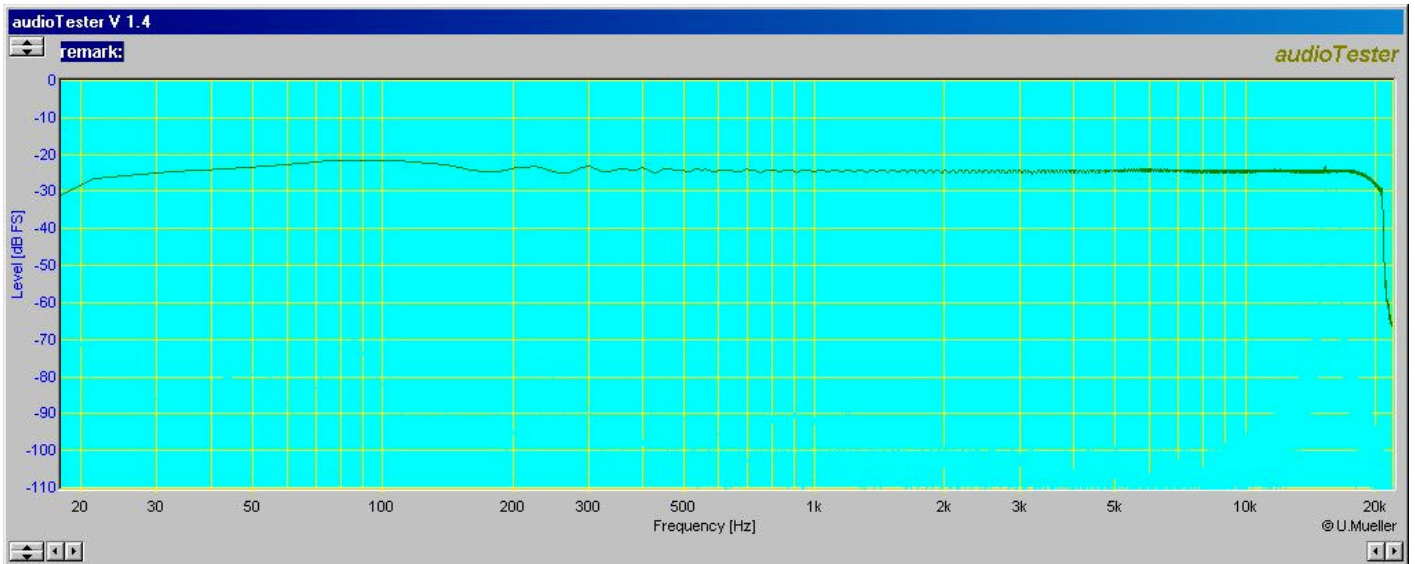
<b>Test Preparation</b>	<ul style="list-style-type: none"> <li>▶ Connect Line IN and Mic IN via termination adapter with Function Generator</li> <li>▶ Set Master Volume at WIN98 Mixer to 0dB (=100% )</li> <li>▶ Start Audio Tester 1.4</li> </ul>
<b>Test Flow</b>	<ul style="list-style-type: none"> <li>▶ Generate a Sine with Function Generator, swept frequencies from 20Hz...20kHz adjust</li> <li>▶ Amplitude -20dB to minimize distortion</li> </ul>
<b>Result</b>	see tables and diagrams below

### Screenshot Line IN



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Screenshot Mic IN



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# 11 Surface Temperature Test

## 11.1 Used Hard- and Software

Hardware	Register
DUT	Box #3
HDD IDE #1	EA0146
CD ROM IDE #1	EA0310
CD ROM IDE #2	EA0206
Power Supply ATX	EA0285
Monitor	EA0221
Keyboard	EA0222
Thermometer	EA0130

Software
Windows 98
Winbench 99

## 11.2 General Conditions

Room Temperature	24°C
Draught	None
CPU	Intel Pentium4 2,4 GHz
Memory	512MB

## 11.3 Test Procedure

<b>Preparation</b>	<p>Build up following Test assembly.</p> <ul style="list-style-type: none"> <li>▶ HDD IDE (Master) and CD-ROM IDE #1 (Slave) mounted at IDE Port 0</li> <li>▶ CD-ROM IDE #2 (Master) mounted on IDE Port 1</li> <li>▶ Connect LAN Interface to KEM Network</li> <li>▶ Connect Audio output of CD-ROM #2 with Line Input of DUT</li> <li>▶ Connect Active Loudspeakers to DUT</li> </ul>
<b>Flow</b>	<ol style="list-style-type: none"> <li>1. Run wrver.bat <ul style="list-style-type: none"> <li>▶ Explanation of driveletters: C:\HDD IDE Z:\Network Drive</li> <li>▶ wrver.bat: <pre>md c:\test copy z:\*. * c:\test fc z:\*. * c:\test\*. * deltree /y e:\test wrver.bat</pre> </li> </ul> </li> <li>2. Insert Audio CD into CD-ROM Drive #2 and play it</li> <li>3. Run Benchmark Program WinBench 99 All Tests, All Winmarks</li> <li>4. Copy a test Folder located on EVAL_Server to DUT</li> <li>5. Measure Surface Temperature of components exceeding 35°C with a digital thermometer after 1 hour running.</li> </ol>
<b>Result</b>	See following table

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## 11.4 Result

List all components exceeding 35°C

Component	Measurement point	Manufacturer specification [°C]	Remark Surface, Ambient, Junction...	Surface Temp [°C]	$D_T$ [°C]	$T_{room\ max}$
U13 MOSFET Driver	Case Surface	85	Ambient operating Temperature	43	42	66
U11 MOSFET Driver	Case Surface	85	Ambient operating Temperature	41	44	68
U8 MOSFET Driver	Case Surface	85	Ambient operating Temperature	42	43	67
U10 Core Voltage Reg.	Case Surface	70	Ambient operating Temperature	41	29	53
Q6 MOSFET	Case Surface	175	Junction Temperature	38	See Datasheet	
Q9 MOSFET	Case Surface	175	Junction Temperature	43	See Datasheet	
Q5 MOSFET	Case Surface	175	Junction Temperature	44	See Datasheet	
Q8 MOSFET	Case Surface	175	Junction Temperature	45	See Datasheet	
Q4 MOSFET	Case Surface	175	Junction Temperature	44	See Datasheet	
Q7 MOSFET	Case Surface	175	Junction Temperature	42	See Datasheet	
U9 RS232 Driver	Case Surface	70	Ambient operation Temperature	48	22	46
U7 RS232 Driver	Case Surface	70	Ambient operation Temperature	45	25	49
U12 Clock Generator	Case Surface	70	Ambient operation Temperature	40	30	54
U16 Northbridge	Case Surface	92	Case Temperature	43	49	73
Q28 MOSFET	Case Surface		n. a.	37	n. a.	
Q27 MOSFET	Case Surface		n. a.	37	n. a.	

**Maximum Measured Surface Temperature: 48 °C**

$$\Delta T = T_{spec} - T_{sur}$$

$T_{spec}$  => manufacturer specified surface/ambient Temperature  
 $T_{sur}$  => measured case surface temperature

$$T_{roommax} = T_{room} + \Delta T$$

$T_{room}$  => actual room temperature  
 $T_{roommax}$  => maximum rated room temperature

**Maximum Room Ambient Temperature Rating: 46 °C**

Please be aware, that this calculation is without processor. However the processor will probably be the most temperature critical component of an application. PGA478 P4 processors max. case temperatures range from 75°C down to 68°C.

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## 11.5 Manual Specifications

The manual specifications define the maximum operating temperature as the maximum measurable temperature on any spot on the module's surface.

Operating Temperature according to Manual	0°C - 50°C
Storage Temperature according to Manual	-10°C – 85°C

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# 12 Max Temperature Test

## 12.1 Used Hard- and Software

Hardware	Register
DUT	BOX 2
ChipDisk	EA0120
Keyboard	EA0111
Monitor	EA0249
Climatic Chamber	EA022
Measuring Device	EA0157
Power Supply ATX	EA0235

Software
MS-DOS 6.22
Checkit4

## 12.2 Temperature Tests at -40°C and +60°C

### 12.2.1 Startup / Function Test

<b>Preparation</b>	<ul style="list-style-type: none"> <li>▶ Nominal Power Supply Voltage: 5.000V</li> <li>▶ Stay at specified temperature: 30 min</li> <li>▶ Time between Power off and on : 1min</li> </ul>			
<b>Flow</b>	<ul style="list-style-type: none"> <li>▶ Boot MS-DOS 20 times (Power on / Power off)</li> <li>▶ Run CHECKIT4 tests with loopback connectors:  <ul style="list-style-type: none"> <li>&lt;Systemplatine&gt;</li> <li>&lt;Serielle Schnittstelle&gt;</li> <li>&lt;Parallele Schnittstelle&gt;</li> </ul> </li> </ul>			
	at -40°C		at +60°C	
<b>Result</b>	<b>X</b>	Test passed successfully	<b>X</b>	Test passed successfully
		Test failed because		Test failed because
		Test skipped because		Test skipped because

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# 13 Maximum Current Test

## 13.1 Used Hard- and Software

Hardware	Register
DUT	BOX 3
CompactFlash	SanDisk
Keyboard	EA0290
Monitor	EA0221
Climatic Chamber	EA0241
Ppower Supply ATX	EA0286
Power Supply HP	EA0145
Measuring Device	EA0158
Measuring Device	PPC ETX
Measuring Device	PPC ETX
Measuring Device	EA0157
HDD IDE	EA0251
Power Supply	EA0020

Software
MS-DOS 6.22
Memtest.exe
Windows 98
Winbench99

## 13.2 General Conditions

Nominal CPU Clock: **2,4 Ghz**  
 Memory: **512 MB**

No keyboard  
 No floppy disk drive  
 No other external devices

## 13.3 Power Consumption DOS

### 13.3.1 Remark

Power Consumption of a board is measured in three ways. The first method is on DOS prompt without the DOS TSR power.exe, during the second power.exe is running in background. The third measurement is during memtest.exe a DOS based memory test tool.

Using BIOS internal routines for Power Management is equivalent to using power.exe, because this TSR uses BIOS APM functions.

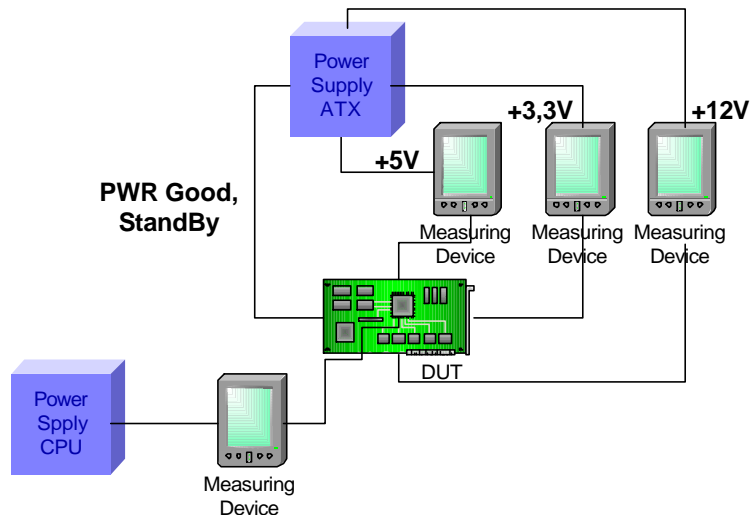
Settings:

- ▶ Set Power Management to enabled
- ▶ Set Standby Time to 1 min
- ▶ Set Suspend Time to 1 min

MS DOS Tool *Power.exe* does not significantly reduce Power Consumption and is for that reason not used.

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### 13.3.2 Test Preparation



### 13.3.3 Result

Conditions		Result			
APM	Temperature	Supply Voltage	Current [A]	Power [W]	Total [W]
Power Management <i>Max Saving</i> enabled.	Room Temp	CPU	1,17	14,04	25,411
		3,3 V	2,37	7,821	
		+ 5 V	0,11	0,55	
		+ 12 V	0,25	3	
		CPU -10%	1,23	13,284	24,705
		3,3 V	2,37	7,821	
		+ 5 V	0,12	0,6	
		+ 12 V	0,25	3	
		CPU +10%	1,11	14,652	26,143
		3,3 V	2,37	7,821	
		+ 5 V	0,11	0,55	
		+ 12 V	0,26	3,12	
Without Power Management.	Room Temp	CPU	2,74	32,88	44,251
		3,3 V	2,37	7,821	
		+ 5 V	0,11	0,55	
		+ 12 V	0,25	3	
		CPU -10%	3,03	32,724	44,095
		3,3 V	2,37	7,821	
		+ 5 V	0,11	0,55	
		+ 12 V	0,25	3	
		CPU +10%	2,59	34,188	45,679
		3,3 V	2,37	7,821	
		+ 5 V	0,11	0,55	
		+ 12 V	0,26	3,12	
Memtest	Room Temp	CPU	3,62	43,44	58,161
		3,3 V	3,37	11,121	
		+ 5 V	0,12	0,6	
		+ 12 V	0,25	3	
		CPU -10%	3,81	41,148	55,886
		3,3 V	3,36	11,088	
		+ 5 V	0,13	0,65	
		+ 12 V	0,25	3	
		CPU +10%	3,37	44,484	59,359
		3,3 V	3,35	11,055	
		+ 5 V	0,14	0,7	
		+ 12 V	0,26	3,12	

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## 13.4 Power Consumption Winbench99

<b>Conditions</b>	Temperature: Room Voltage: Nominal			
<b>Flow</b>	Start Winbench99 with selected test suite of Performance Test (+graphics benchmarks) Measure max current during benchmark is running			
<b>Result</b>	Current	<b>Supply Voltage</b>	<b>Current in A</b>	<b>Power Consumption in W</b>
		CPU	4,31	51,72
		3,3 V	3,21	10,593
		+ 5 V	0,15	0,75
	+ 12 V	0,45	5,4	
Power Consumption total	<b>68,46 W</b>			

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# 14 Power Supply and Wires

## 14.1 General Definitions

The Power Supply test specifies the requirements that the power supply should fulfill at least. To calculate these values it is necessary to determine the current consumption of the assembly first.

Supply voltage:		<b>Nominal</b>
Measured current consumption $I_{meas}$ :	CPU	<b>4,31 A</b>
	3,3 V	<b>3,21 A</b>
	+ 5 V	<b>0,15 A</b>
	+ 12 V	<b>0,45 A</b>

## 14.2 Result

		Formula	Result
Minimum cross cut section of Power supply cords		radius assumed to be $r = 0,5\text{mm}$	
Maximal length of power supply cords	CPU	$l = \frac{\Delta U * \gamma * A}{2 * I}$ whereby $\Delta U$ = permitted voltage drop (3% of $V_{CPU}$ ) $l$ : length of power cords $I$ : $I_{meas} * 2$ $\gamma$ : electr. Conductivity of the material $\gamma_{copper} \Rightarrow 57\text{m}/\Omega * \text{mm}^2$ $A$ : cord cross section $(= \Pi * r^2 = 0.785 \text{ mm}^2)$	$l = \frac{0,36 * 57 * 0,785}{2 * 8,62}$  <b><math>I_{max} = 0,93 \text{ m}</math></b>
	$V_{3,3}$	see CPU formula	$l = \frac{0,099 * 57 * 0,785}{2 * 6,42}$  <b><math>I_{max} = 0,34 \text{ m}</math></b>
	$V_5$	see CPU formula	$l = \frac{0,15 * 57 * 0,785}{2 * 0,3}$  <b><math>I_{max} = 11,19 \text{ m}</math></b>
	$V_{12}$	see CPU formula	$l = \frac{0,36 * 57 * 0,785}{2 * 0,9}$  <b><math>I_{max} = 8,95 \text{ m}</math></b>
Minimal output of power supply		$P_{power\ supply} = V * I_{meas} * 2$ Whereby $V_{cc}$ : nominal supply voltage $I_{meas}$ : measured current consumption	<b><math>P_{power\ supply} = 136,92 \text{ W}</math></b>

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# 15 Real Time Clock Test

## 15.1 Used Hard- and Software

Hardware	Register
DUT	Box1
HDD IDE	EA0146
Keyboard	EA0111
Monitor	EA0249
ChipDisk	EA0120
Climatic Chamber	EA0241
Ppower Supply ATX	EA0235
Power Supply HP	EA0030
Measuring device	EA0157

Software
MS-DOS 6.22
Checkit 3
AMIDIAG 5.42
AtomTime.exe

## 15.2 Test with Checkit & Amidiag

Preparation	Build up Test assembly and boot MS-DOS 6.22				
Flow	Testsoftware	Conditions		Result	
	Checkit: Run 5 cycles of → Tests → "Systemplatine"	-30°C	Nom		OK
		Nom	3,14 V	3,3 V Supply +/- 5%	OK
			3,63 V		OK
		+60°C	Nom		OK
	Amidiag: Run 5 cycles of → System → Real Time Clock Test	-30°C	Nom		<i>RTC Periodic Interrupt not coming.</i> This is a known behaviour of the Test software with comparatively fast processors and not seen as a problem.
		Nom	3,14 V	3,3 V Supply +/- 5%	
			3,63 V		
+60°C	Nom				

## 15.3 15h Tests

### 15.3.1 General Annotations

The CMOS Real Time Clock is powered by onboard or external battery and therefore runs also, when the board is not connected to the power supply. During Bootup the BIOS reads out CMOS Date and Time and sets the System (DOS) Time to the values of the CMOS RTC. Calling time operations under OSs will always return System Time.

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### 15.3.2 15h CMOS Clock Test

<b>Preparation</b>	<ul style="list-style-type: none"> <li>▶ Assure that there is a battery to supply the CMOS RTC of the DUT</li> <li>▶ Install AtomTime ( connects to an exact atomic clock via internet and calculates the divergence to System Time )</li> <li>▶ Call up AtomTime and set System Time to Atomic Time</li> </ul>
<b>Flow</b>	<ul style="list-style-type: none"> <li>▶ Shut down the DUT and wait for 15 hours</li> <li>▶ Start DUT, run AtomTime and calculate divergence</li> <li>▶ Assure that the local system time is not set to the server time at logon.</li> </ul>
<b>Result</b>	Local PC Difference: <b>Clocks match</b>
	<input checked="" type="checkbox"/> Test passed successfully
	<input type="checkbox"/> Test failed because
	<input type="checkbox"/> Test skipped because

### 15.3.3 15h System Clock Test

<b>Preparation</b>	<ul style="list-style-type: none"> <li>▶ Install AtomTime ( connects to an exact atomic clock via internet and calculates the divergence to System Time )</li> <li>▶ Run AtomTime and set System Time to Atomic Time</li> </ul>
<b>Flow</b>	<ul style="list-style-type: none"> <li>▶ Wait for 15 hours</li> <li>▶ Run AtomTime and calculate divergence</li> </ul>
<b>Result</b>	Local PC Difference: <b>5 sec. ahead</b>
	<input checked="" type="checkbox"/> Test passed successfully
	<input type="checkbox"/> Test failed because
	<input type="checkbox"/> Test skipped because

## 15.4 Battery

If the DUT is supplied with an external battery, measure current consumption.

Nominal Battery Voltage : 3,0 V

### 15.4.1 Power supply off

Measured Battery Voltage [V]	Current [ $\mu$ A]	Power Consumption [ $\mu$ W]
3,0	12,4	36,95

### 15.4.2 Power supply on

Measured Battery Voltage [V]	Current [ $\mu$ A]	Power Consumption [ $\mu$ W]
3,0	-6,94	20,82

### 15.4.3 Voltage on battery socket

<b>Preparation</b>	<ul style="list-style-type: none"> <li>▶ Take battery out of socket</li> <li>▶ Turn on power supply</li> </ul>
<b>Flow</b>	▶ Measure voltage over battery connection pads and assure that no voltage from the board is fed back to the battery
<b>Result</b>	Measured voltage: <b>3,24 V</b>

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# 16 Mechanical and Hardware Requirements

## 16.1 USB Protection

	Assure that a resettable overcurrent limiting mechanism like PTC or solid state switch is used to protect the USB powerline; a coil is not sufficient for this purpose	
Result	X	Test passed successfully
		Test failed because
		Test skipped because

## 16.2 Comparison To Form Factor Spec

	Assure that the dimensions of DUT matches the corresponding form factor specs such as PC104 / ETX / DIMM / PICMG / Half Size / ....	
Result	X	Test passed successfully, exceptions are described in the manual
		Test failed because
		Test skipped because board does not correspond to any form factor.

## 16.3 Fixing Holes

	Assure that there are fixing holes with the specified correct diameter for <ul style="list-style-type: none"> <li>▶ the board itself</li> <li>▶ the chipdisk, flash disk</li> <li>▶ extension modules</li> </ul>	
Result	X	Test passed successfully
		Test failed because
		Test skipped because

## 16.4 Battery Circuit Protection

	<b>According to EN60950 batteries have to be protected twice against charging. This double protection can consist out of</b> <ol style="list-style-type: none"> <li>a) Diode and a resistor</li> <li>b) 2 x Diode</li> </ol>	
Result	X	Test passed successfully
		Test failed because
		Test skipped because

## 16.5 Memory, Chipdisk, Fan,...

	Assure that memory, chipdisk, display adapter, compact flash, pcmcia card, cooler and fan can be equipped at the same time without mechanical restrictions for any component	
Result	X	Test passed successfully
		Test failed because
		Test skipped because

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## 17 Mean Time between Failures (MTbF)

The mean time between failures (MTBF) prediction is calculated using component and subassembly random failure rates. The calculation is based on the Bellcore Reliability Prediction Procedure, TR-NWT-000332, Issue 4, September 1991. The MTBF data is calculated from predicted data at 55 °C. The 886LCD-ATXU board MTBF is **111,732 hours**.

## 18 Product Safety Test

### 18.1 General Definitions

The Product safety test assures that the tested device complies with the European standard EN 60950. The conformity with EN 60950 is mandatory for electrical devices used in the information technology. It states, that the device fulfills the Low Voltage Directive and at least flammability class 94V-0. The certificate is written out by the following institution:

Result:

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## 19 Summary Of Test Results 886LCD/ATX

Chapter	Description	Seriousness	Status
	Remark: <i>RTC Periodic Interrupt not coming</i> . This is a known behaviour of the Test software with comparatively fast processors and not seen as a problem.	info	reported

## 20 Revision History

Date: 10.02.2003

A0

Document created

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